

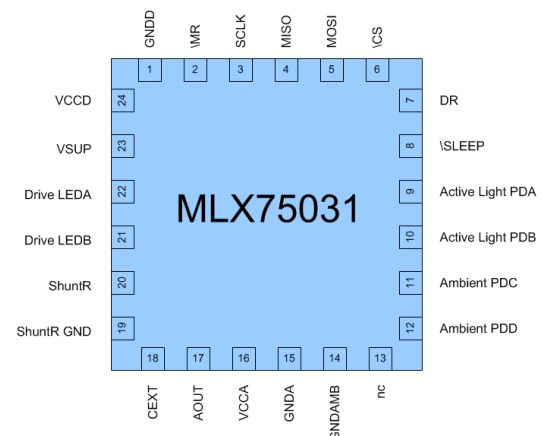
## Features & Benefits

- Two independent Active Light measurement channels for proximity sensing and/or gesture recognition
- Integrated DC light cancellation circuitry
- Two logarithmic ambient light channels with two different sensitivities
- Minimum amount of external components
- Stand-by and sleep modes for low power consumption
- Integrated LED drivers
- Integrated battery voltage monitor
- Integrated LED temperature sensing circuitry
- Integrated 16bit ADC for high resolution A2D conversion
- Integrated temperature sensor
- Integrated watchdog timer
- Easy digital communication interface via SPI
- High input capacitance tolerant input current terminals
- High safety design by several diagnostic and monitoring functions

## Applications

- Robust Proximity Sensing
- Smart Touch Displays & Panels
- Simple Gesture Detection
- Driver-Passenger Discrimination
- Ambient Light Sensing & Display Dimming

## Functional Diagram



## Ordering Information

### Product Code

MLX75031

MLX75031

### Temperature Code

R (-40°C to 105°C)

C (0°C to 70°C)

### Package Code

LQ (QFN24 4x4)

LQ (QFN24 4x4)

### Option Code

B

B

## General Description

The MLX75031 Optical Gesture & Proximity Sensing IC actively controls up to 2 independent Active Light measurement channels. Each channel consists out of one or multiple LEDs, of any type, combined with one or more photodiodes, of any type. Additional Active Light channels can be added through multiplexing. Integrated DC light suppression makes the sensors highly tolerant to background light interference. Primary function is complemented with two integrated ambient light channels. Internal control logic, configurable user registers and SPI communication enable intuitive & programmable operation. Extra features include a watchdog timer, on-board temperature sensor and self-diagnostics are built-in to facilitate robust product design.

The digital output from the Active Light and ambient light channels can be used for proximity and ambient light detection. Gestures such as swipe, zoom, scroll can be recognized by software algorithms that can run on the customer's microcontroller. Reliable communication is assured via an SPI interface.

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## 1. Functional Block Diagram

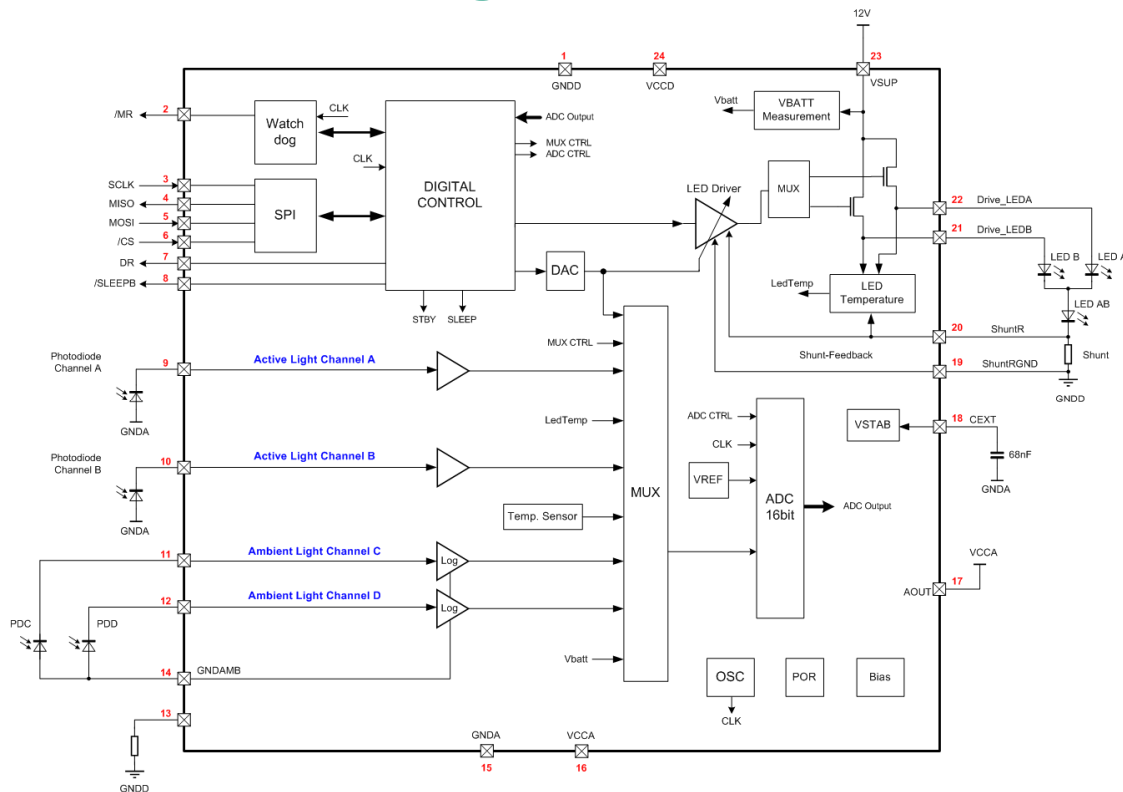


Figure 1 : MLX75031 Functional Block Diagram

## 2. Device Overview

The MLX75031 Optical Gesture & Proximity Sensing IC independently controls up to 2 Active Light channels. Both channels, A and B, have externally connected photodiodes. External LEDs can be driven up to 150 mA by the built-in LED driver. This current drive capability can also be used to drive a low cost bipolar transistor to increase the peak LED current. The chip synchronizes the pulsing of the LEDs and the exposure time of the Active Light channel photodiodes whereby ambient light and reflected LED light are detected separately. Any spurious light source is subtracted from the Active Light signal. See Section 8.1.

The two logarithmic current sensing channels C and D can be used to measure ambient light over a very wide intensity range. See Section 8.2 for more details.

As auxiliary features, the sensor integrates a watchdog timer, can measure its own temperature, the LED temperature, monitor voltage supply level and perform self diagnostics.

All of this information is available via the SPI interface.

See Section 8.14, 8.3, 8.5.3, 8.5.4 or 8.11.8 for detailed information.

The sensor features sleep and standby modes to save on current consumption. (Section 8.11.2)

The SPI interface is used for data transfer and control of the IC. The timing characteristics are explained in Section 8.11.1 and the interface commands and programmable options in Section 8.11.3 & 8.13.

The sensor is available in both consumer and automotive temperature grades.

## 3. Glossary of Terms

|        |                                       |
|--------|---------------------------------------|
| CR     | Chip Reset                            |
| CRC    | Cyclic Redundancy Check               |
| CS     | Chip Select                           |
| CSLP   | Confirm Sleep                         |
| CSTBY  | Confirm Standby                       |
| DAC    | Digital to Analog Converter           |
| DC     | Direct Current                        |
| DR     | Device Ready                          |
| EMC    | Electromagnetic Compatibility         |
| GNDA   | Ground for analog blocks of MLX75031  |
| GNDD   | Ground for digital blocks of MLX75031 |
| IR     | Infrared                              |
| LPF    | Low-pass filter                       |
| LSB    | Least Significant Bit                 |
| MISO   | Master In Slave Out                   |
| MOSI   | Master Out Slave In                   |
| MR     | Master Reset                          |
| MSB    | Most Significant Bit                  |
| MUX    | Multiplexer                           |
| NOP    | No Operation                          |
| NRM    | Normal Running Mode                   |
| OSC    | Oscillator                            |
| OTR    | Optical transfer ratio                |
| POR    | Power on reset                        |
| RCO    | RC-Oscillator                         |
| RO     | Read-Out                              |
| RR     | Read Register                         |
| RSLP   | Request Sleep                         |
| RSTBY  | Request Standby                       |
| SCLK   | SPI Shift Clock                       |
| SM     | Start Measurement                     |
| SNR    | Signal-to-Noise Ratio                 |
| SPI    | Serial Peripheral Interface           |
| TIA    | Transimpedance Amplifier              |
| VCCA   | Supply Voltage for the analog blocks  |
| VCCD   | Supply Voltage for the digital blocks |
| VSENSE | Voltage across the shunt resistor     |
| WDT    | Watchdog Timer                        |
| WR     | Write Register                        |
| uC     | Microcontroller                       |

## 4. Absolute Maximum Ratings

| Parameter   | Symbol                                    | Conditions   | Min  | Max                        | Units |
|---|---|--|------|----------------------------|-------|
| Supply Voltage range  | VCCD, VCCA                                |  | -0.3 | 5.0                        | V     |
| Battery Supply Voltage range  | VSUP                                      | t<400ms, no functionality, only during load dump               | -0.3 | 40                         | V     |
|   |   | t<2min, functional, not guaranteed to be within specifications | -0.3 | 28                         | V     |
| Voltage range Drive_LED A and Drive_LED B                                   |   |  | -0.3 | 5.5                        | V     |
| Voltage range on all pins except VCCD, VCCA, VSUP, Drive_LED A, Drive_LED B |   |  | -0.3 | V(VCCD)+0.3<br>V(VCCA)+0.3 | V     |
| Terminal current  | I <sub>terminal</sub><br>I <sub>LED</sub> | per bondpad<br>Battery connection                              | -20  | +20                        | mA    |
|   |   |  | -20  | +155                       | mA    |
| Storage temperature   | T <sub>stg</sub>                          |  | -40  | +150                       | °C    |
| Junction temperature  | T <sub>j</sub>                            |  |      | +150                       | °C    |
| ESD capability of any pin (Human Body Model)                                | ESDHBM                                    | Human body model, acc. to AEC-Q100-002 Rev D                   | -2   | +2                         | kV    |
| ESD capability of any pin (Charge device model)                             | ESDCDM                                    | Charge device model acc. to AEC- Q100-011 Rev B                | -500 | +500                       | V     |
| Maximum latch-up free current at any pin                                    | I <sub>LATCH</sub>                        | JEDEC- Standard EIA / JESD78                                   | -100 | +100                       | mA    |

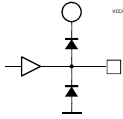




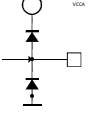
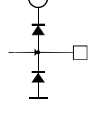
*Table 1 : Absolute maximum ratings*

**Note :** Exceeding the absolute maximum ratings may cause permanent damage.  
 Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

## 5. Pin Definitions & Descriptions

| Pin No | Name              | Functional Schematic | Type                                    | Function                                   |
|--------|-------------------|----------------------|---|--|
| 1      | GNDD              |                      | Ground                                  | Ground                                     |
| 2      | \MR               |                      | Digital Open Drain Light Output         | Master Reset                               |
| 3      | SCLK              |                      | Digital Input with pull-up              | SPI Shift Clock                            |
| 4      | MISO              |                      | Digital push-pull Output with Tri-state | SPI Data Output                            |
| 5      | MOSI              |                      | Digital Input with pull-down            | SPI Data Input                             |
| 6      | \CS               |                      | Digital Input with pull-up              | Chip Select                                |
| 7      | DR                |                      | Digital push-pull Output                | Device Ready                               |
| 8      | \SLEEPB           |                      | Digital push-pull Output                | Sleep Detect                               |
| 9      | Active Light PDA  |                      | Analog Input                            | IR Photo Diode A                           |
| 10     | Active Light PDB  |                      | Analog Input                            | IR Photo Diode B                           |
| 11     | Ambient Light PDC |                      | Analog Input                            | Ambient Light Photo Diode C                |
| 12     | Ambient Light PDD |                      | Analog Input                            | Ambient Light Photo Diode D                |
| 13     | n.c               |                      | Analog Input                            | Test Pin, connect to ground via a resistor |

Datasheet

|    |            |   |               |  |
|----|------------|---|---------------|--|
| 14 | GNDAMB     |    | Analog I/O    | Ground Ambient Light Channels            |
| 15 | GNDA       |   | Ground        | Ground                                   |
| 16 | VCCA       |   | Supply        | Regulated Power Supply                   |
| 17 | AOUT       |    | Analog I/O    | Test Pin, connect to VCCA                |
| 18 | CEXT       |    | Analog Input  | External blocking Cap, connected to GNDA |
| 19 | ShuntRGND  |    | Analog Input  | Shunt resistor feedback to Ground        |
| 20 | ShuntR     |    | Analog Input  | Shunt resistor feedback                  |
| 21 | Drive_LEDB |    | Analog Output | IR LED Emitter B                         |
| 22 | Drive_LEDA |  | Analog Output | IR LED Emitter A                         |
| 23 | VSUP       |   | Supply        | LED driver supply                        |
| 24 | VCCD       |   | Supply        | Regulated Power Supply                   |

*Table 2 : Pin definitions and descriptions*

**Note :** Pins of measurement channels that are not used, can be left unconnected.  
 However, this can lead to an error indicated by the corresponding error flags in the Error register.



## 6. General Electrical Specifications

| Parameter                                | Symbol     | Test Conditions   | Min    | Typ | Max        | Units    |
|--|------------|---|--------|-----|------------|----------|
| Supply voltage range                     | VDD        | VCCD and VCCA pin   | 3.135  | 3.3 | 3.465      | V        |
| Supply current (active mode)             | IDD        | I(VCCD)+I(VCCA)<br>without photodiode DC<br>current                           |        |     | 6          | mA       |
| Supply current<br>(standby mode)         | IDD_STBY   | I(VCCD)+I(VCCA)   |        |     | 350        | uA       |
| Supply current (sleep mode)              | IDD_SLP    | I(VCCD)+I(VCCA)<br>without SPI<br>communication                               |        |     | 30         | uA       |
| Battery supply voltage range             | VSUP       | VSUP pin  | 6      |     | 18         | V        |
| Battery supply current<br>(active mode)  | IVSUP      | I(VSUP) with<br>Active Light pulses<br>I(VSUP) without<br>Active Light pulses | 0<br>0 |     | 155<br>0.1 | mA<br>mA |
| Battery supply current<br>(standby mode) | IVSUP_STBY | I(VSUP)   | 0      |     | 10         | uA       |
| Battery supply current<br>(sleep mode)   | IVSUP_SLP  | I(VSUP)   | 0      |     | 10         | uA       |
| Operation Temperature                    | TA         |   | -40    |     | 105        | °C       |

*Table 3 : Electrical specifications*

## 7. Sensor Interface Specific Specifications

The following characteristics are valid over the full temperature range of  $T_A = -40^{\circ}\text{C}$  to  $+105^{\circ}\text{C}$  and a supply range of  $V_{SUP} = 6.18\text{V}$  and  $V_{CCD} = V_{CCA} = 3.135..3.465\text{V}$  unless otherwise noted.

| Active Light Channels (Photodiode A & B)   |                                     |  |       |            |       |                    |
|--|-------------------------------------|--|-------|------------|-------|--------------------|
| Parameter  | Symbol                              | Test Conditions  | Min   | Typ        | Max   | Units              |
| Optical transfer ratio   | $OTR = \frac{I_{LED}}{I_{PD}}$      |  | 30    |            | 12000 |                    |
| DC sunlight current in the photodiode  | $I_{sun}$                           |  | 0     |            | 900   | $\mu\text{A}$      |
| Fast full scale transition at $I_{sunmax}$   | $t_{sunrise}$                       |  | 3.5   |            |       | ms                 |
| Min. relative active light modulation (referred to received IR signal)                                   | $\frac{\Delta I_{PD\_min}}{I_{PD}}$ | - 20 $\mu\text{s}$ LED pulse<br>- PD pulsed current $\geq 20\mu\text{A}$ , - $25^{\circ}\text{C}$<br>- DC sun constant<br>- response per channel 2.5ms |       | 1          | 5 (*) | %                  |
| Dynamic range of active light events (referred to received IR signal)                                    | $\Delta I_{ActiveLight}$            |  |       |            | 80    | %                  |
| Active light repetition time<br>Active light measurement channel A, channel B                            | $t_{rep\_activelight}$              |  |       | 2.5<br>2.5 |       | ms<br>ms           |
| LED pulse duration range   | $t_0$                               | selectable via register  | 15-8% |            | 30+8% | $\mu\text{s}$      |
| Max. input capacitance PDA & PDB   | $C_{PDA}, C_{PDB}$                  |  |       |            | 80    | pF                 |
| DC light measurement range   | $I_{DC}$ range                      |  | 0     |            | 900   | $\mu\text{A}$      |
| DC light measurement offset  | $I_{DC}$ offset                     | $I_{DC} = 0\mu\text{A}$ & $V_{DD}=3.3\text{V}$   | 1360  | 1960       | 2460  | LSB                |
| DC light measurement slope   | $I_{DC}$ sens                       |  | 28    | 35         | 44    | LSB/ $\mu\text{A}$ |
| DC light measurement linearity error   |                                     | $I_{DC}$ range: $0\mu\text{A} \rightarrow 900\mu\text{A}$  |       | 5          | 8     | %                  |
| DC light measurement word length   |                                     |  |       | 16         |       | Bit                |
| DC light measurement noise   |                                     | for averaging of 8 measurements  |       | 3          |       | Bit                |
| Error condition Err_TIA  |                                     |  |       |            |       |                    |
| Critical error detected on TIA output, if TIA output outside $1.1\text{V} \pm (0.65 \dots 0.75\text{V})$ |                                     |  |       |            |       |                    |

Table 4 : Active Light Channels Specification

(\*) The 5% is really worst case condition, i.e. with  $OTR = 30$  and  $R_{shunt} = 10\Omega$ , this condition is not realistic and should be avoided in the application

*Table 5 : Ambient Light Channels Specifications*

| <b>Ambient Light Channels (Photodiode C &amp; D)</b>   |                          |   |       |       |       |         |
|--|--------------------------|---|-------|-------|-------|---------|
| Parameter  | Symbol                   | Test Conditions   | Min   | Typ   | Max   | Units   |
| Input current range for detector C   | I <sub>ambc</sub>        | Detector C  | 0.01  |       | 1040  | uA      |
| Input current threshold level  | I <sub>ambc_detect</sub> | Detector C  | 333   |       |       | nA      |
| Input capacity on ambient PDC  | C <sub>ambc</sub>        | at 1V, Detector C   |       |       | 1     | nF      |
| Input current range for detector D   | I <sub>ambd</sub>        | Detector D  | 0.002 |       | 20    | uA      |
| Input current threshold level  | I <sub>ambd_detect</sub> | Detector D  | 22    |       |       | nA      |
| Input capacity on ambient PDD  | C <sub>ambd</sub>        | at 1V, Detector D   |       |       | 100   | pF      |
| Transfer function logarithmic  | V <sub>amb</sub>         | See Section 8.2.2   |       |       |       |         |
| Output Ambient Channel C   |                          | At VDD=3.3V, I <sub>in</sub> =100uA   | 30464 | 32768 | 37376 | LSB     |
| Output Ambient Channel D   |                          | At VDD=3.3V, I <sub>in</sub> =10uA  | 30464 | 32768 | 37376 | LSB     |
| Slope Ambient Channel C  |                          | At VDD=3.3V and 105°C   | 5300  | 5900  | 6500  | LSB/dec |
| Slope Ambient Channel D  |                          | At VDD=3.3V and 105°C   | 5300  | 5900  | 6500  | LSB/dec |
| Ambient Channels Linearity Error   |                          | for I <sub>in</sub> ≥ I <sub>ambx_detect</sub>  |       | 3     | 5     | %       |
| Ambient light word length  |                          |   |       | 16    |       | bits    |
| Ambient light channel accuracy   |                          | for averaging of 16 measurements  |       | 13    |       | bits    |
| Ambient light response time  |                          | See Section 8.2.4 for a detailed explanation of this parameter.<br>for I <sub>in</sub> ≥ I <sub>ambx_detect</sub> |       |       | 3     | ms      |
| Ambient light measurement repetition rate  |                          |   | 10    |       |       | ms      |
| <b>Error condition Err_Amb</b>   |                          |   |       |       |       |         |
| Err_Amb it is set if the output common mode of one ambient channel SC filter is out of range (meaning > 55% of VCCA for each of the differential outputs). |                          |   |       |       |       |         |

*Table 6 : Temperature Sensor Specification*

| Die Temperature Sensor             |   |                                       |      |      |       |       |
|------------------------------------|---|---------------------------------------|------|------|-------|-------|
| Parameter                          | Symbol  | Test Conditions                       | Min  | Typ  | Max   | Units |
| Temp. sensor range                 | $\vartheta$                                   |                                       | -40  |      | 105   | °C    |
| Temp. sensor transfer function (*) | $V\vartheta$                                  | At VDD=3.3V                           | -82  | -67  | -51   | LSB/K |
| Temp. sensor output                | $V@85^{\circ}\text{C}$                        | At VDD=3.3V and full Calib 1/2 ranges | 5990 | 8096 | 10203 | LSB   |
| Temp. sensor error                 | $\vartheta_{\text{error}@30^{\circ}\text{C}}$ | At VDD=3.3V                           |      |      | ±3    | °C    |
| Temp. response time                | $t_{\text{resp}}\vartheta$                    |                                       |      |      | 1     | s     |
| Temp. sensor word length           |   |                                       |      | 16   |       | bits  |
| Temp. sensor noise                 |   | for averaging of 16 measurements      |      | 3    |       | bits  |

(\*) This value will be stored in the Calib1 Register.

| LED Driver   |                        |   |     |      |     |       |
|--|------------------------|---|-----|------|-----|-------|
| Parameter  | Symbol                 | Test Conditions   | Min | Typ  | Max | Units |
| LED pulse current  |                        | Shunt=1 $\Omega$  | 1   |      | 150 | mA    |
| Shunt resistor values  |                        | The minimum VSUP voltage is affected by the drop across the shunt resistor  | 1   |      | 6.6 | Ohm   |
| Shunt voltage  |                        |   | 1   |      | 993 | mV    |
| Rising and falling time  |                        | 1tau settling time, programmable via Rise<1:0>  |     | 1..7 |     | us    |
| DC offset level  |                        | Shunt bias voltage before transmitting the current pulse  |     | 1    |     | mV    |
| Time before pulse  | $T_{\text{dc\_pulse}}$ | Biasing time of the LED driver (Shunt voltage = DC offset level) before pulse transmission. See Section 8.13.0 for details. |     | 200  |     | us    |
| Error condition Err_Drv  |                        |   |     |      |     |       |
| Err_Drv difference between Vdac and Vsense. Detection level larger 200mV |                        |   |     |      |     |       |

*Table 7 : LED Driver specification*

Table 8 : Power on Reset specification

| POR                       |          |                 |     |     |      |       |
|---------------------------|----------|-----------------|-----|-----|------|-------|
| Parameter                 | Symbol   | Test Conditions | Min | Typ | Max  | Units |
| POR off threshold voltage | VPOR-ON  |                 | 1.8 |     | 2.85 | V     |
| POR on threshold voltage  | VPOR-OFF |                 | 1.7 |     | 2.75 | V     |
| POR hysteresis voltage    | VHYS     |                 |     | 150 |      | mV    |

| VSup Voltage Monitor        |              |                                  |     |     |       |       |
|-----------------------------|--------------|----------------------------------|-----|-----|-------|-------|
| Parameter                   | Symbol       | Test Conditions                  | Min | Typ | Max   | Units |
| VSup Measurement Range      |              |                                  | 5   |     | 20    | V     |
| VSup Low threshold voltage  | VTSUPL       | Default VSUPLOW<1:0>             |     | 6   |       | V     |
| VSup Low hysteresis         | VTSUPL_hys   |                                  |     | 1   |       | V     |
| VSup High threshold voltage | VTSUPH       |                                  |     | 20  |       | V     |
| VSup High hysteresis        | VTSUPH_hys   |                                  |     | 1.8 |       | V     |
| Gain error                  | VTgain_err   |                                  |     |     | +/-2  | %     |
| Offset error                | VToffset_err |                                  |     |     | +/-50 | LSB   |
| Voltage Monitor Noise       |              | for averaging of 16 measurements |     | 3   |       | bits  |

Table 9 : VSup Voltage Monitor specification

| SPI                                       |        |   |        |      |        |       |
|---|--------|---|--------|------|--------|-------|
| Parameter                                 | Symbol | Test Conditions   | Min    | Typ  | Max    | Units |
| SPI word length                           |        |   |        |      | 8      | bit   |
| High-level input voltage                  | VIH    |   | 0.7VDD |      | VDD    | V     |
| Low-level input voltage                   | VIL    |   | 0      |      | 0.3VDD | V     |
| Hysteresis on digital inputs              | VHYST  |   |        | 0.28 |        | V     |
| High output voltage<br>(not on pin MR)    | VOH    | CL=30pF   | 0.8VDD |      | VDD    | V     |
| Low output voltage<br>(not on pin MR)     | VOL    | CL=30pF   | 0      |      | 0.2VDD | V     |
| Input leakage                             | ILK    |   | -10    |      | 10     | μA    |
| Tri-state output<br>leakage current       | IOZ    |   | -10    |      | 10     | μA    |
| Input capacitance, per pin                | CIN    |   |        | 10   |        | pF    |
| Pull up resistance<br>of SCLK and \CS Pin | RPU    | PD -> leakage to VCCD<br>(causing a voltage drop<br>across the PD resistor) |        | 50k  |        | Ohm   |

|   |                 |   |     |     |               |     |
|---|-----------------|---|-----|-----|---------------|-----|
| Pull Down Resistance of MOSI Pin  | RPD             | PU -> leakage to GNDD (causing a voltage drop across the PU resistor) |     | 50k |               | Ohm |
| Output voltage Low, Pin MR  | VOutL           | IODC = 2mA  |     |     | 0.1           | V   |
| Start-up time after power-on  | tstartup        |   | -8% | 20  | +8%           | ms  |
| Start-up time after power-on only for SPI   | tstartupSPI     |   |     |     | 10            | μs  |
| Start-up time after wake-up from sleep  | twakeup_slp     |   | -8% | 20  | +8%           | ms  |
| Start-up time after wake-up from standby  | twakeup_st by   |   | -8% | 20  | +8%           | ms  |
| SPI Clock Frequency   | fSCLK = 1/tSCLK |   | 0.5 | 1   | 5             | MHz |
| Frequency of Internal RC Oscillator   | fRCO = 1/TRCO   |   | -8% | 2.5 | +8%           | MHz |
| CS low prior to first SCLK edge   | tcs_sclk        |   | 50  |     |               | ns  |
| CS high after last SCLK edge  | tsclk_cs        |   | 50  |     |               | ns  |
| CS high time between transmissions  | tcs_inter       |   | 50  |     |               | ns  |
| Time between CS high and DR low (*)   | tcs_dr          |   | 0   |     | 22.47 (239us) | μs  |
| WDT initial active window time  | twdt_init       | After POR, Watchdog Reset and Wake-Up                                 | -8% | 140 | +8%           | ms  |
| WDT open window time  | twdt_open       |   | -8% | 70  | +8%           | ms  |
| WDT closed window time  | twdt_closed     |   | -8% | 70  | +8%           | ms  |
| MR low time during reset  | tMR             | After Watchdog Reset  | -8% | 2   | +8%           | ms  |
| SLEEPB low after CS high  | tsleepb         | After CSBTY/CSLP command  | 0   | 1.2 |               | μs  |
| <b>Error condition Err_RCO</b>  |                 |   |     |     |               |     |
| RCO stuck at High or Low  |                 |   |     |     |               |     |
| <b>Error condition Err_Vref</b>   |                 |   |     |     |               |     |
| Internal voltage regulator : Err_Vref is set if the regulator does not start (detection threshold in the range [1V;2V]) |                 |   |     |     |               |     |

*Table 10 : SPI specification*

(\*) with random measurement start, the max time can be up to 239us, if an auto-zeroing phase of the IC is executed.

## 8. Detailed General Description

### 8.1. Active Light Channels A & B

The MLX75031 has two separate Active Light channels. Both channels work synchronously & independently. These channels are able to detect the amplitude/intensity of a reflected signal whilst subtracting the DC variation of the background light or sunlight illumination.

The LEDs transmit one single light pulse (pulse duration is programmable via TP<2:0>) which is detected by the channel receiver. The pulse amplitude is sampled and amplified by a S&H stage synchronized with the LED pulse.

In addition to the LED pulse amplitude programming, the effective trans-impedance can be adjusted in order to maximize the dynamic range of the system.

The calibration to find the best working point should be calculated and set by means of the  $\mu$ Controller over the SPI interface.

#### 8.1.1. Transimpedance Amplifier (TIA)

The transimpedance amplifier converts the photocurrent of the connected photodiode into a voltage signal.

The overall transfer function for the Active Light channels is defined by following formula :

$$I_{pd} = \frac{\left( \frac{ADC\_ActiveLight}{65535} - \frac{1}{2} \right) \times 3.3 + 1.45 \times GAIN\_BUF}{0.02 \times GAIN\_ADJ \times GAIN\_BUF \times k}$$

- $I_{pd}$  : the current through the photo diode (in  $\mu A$ )
- $ADC\_ActiveLight$  : the decimal value of the Active Light measurement (see Output Data Frame of read-out)
- $GAIN\_BUF$  : the gain value selected by the GainBuf register
- $GAIN\_ADJ$  : the gain value selected by the SetAL or SetBL register
- $k$  : Factor causing by signal attenuation from TIA. Range from 50% - 90%.

The TIA's DC-light cancellation circuitry delivers a 16bit value of the received (external) DC light.

### 8.1.2. Active Light Channel DC Light Measurement

The DC current compensation circuitry of the transimpedance amplifier is able to supply and measure the DC current supplied to the photodetector. Both Active Light channels are identical in structure.

In order to reach a feasible resolution in the current range of interest (low currents in the range up to 900uA), the measurement characteristics will saturate for currents above the IDC current range, however the compensation circuit is nevertheless able to supply the specified current levels to the detector (up to 900uA). The given ADC word length for the Active Light channel DC light data is 16bit.

The typical transfer function of DC measurement is defined by formula:

$$I_{pd\_DC} = \frac{ADC\_DC - 1760}{35}$$

$I_{pd\_DC}$  : The DC current through photo diode (in uA).

ADC\_DC : the decimal value of the DC measurement (see Output Data Frame of read-out).



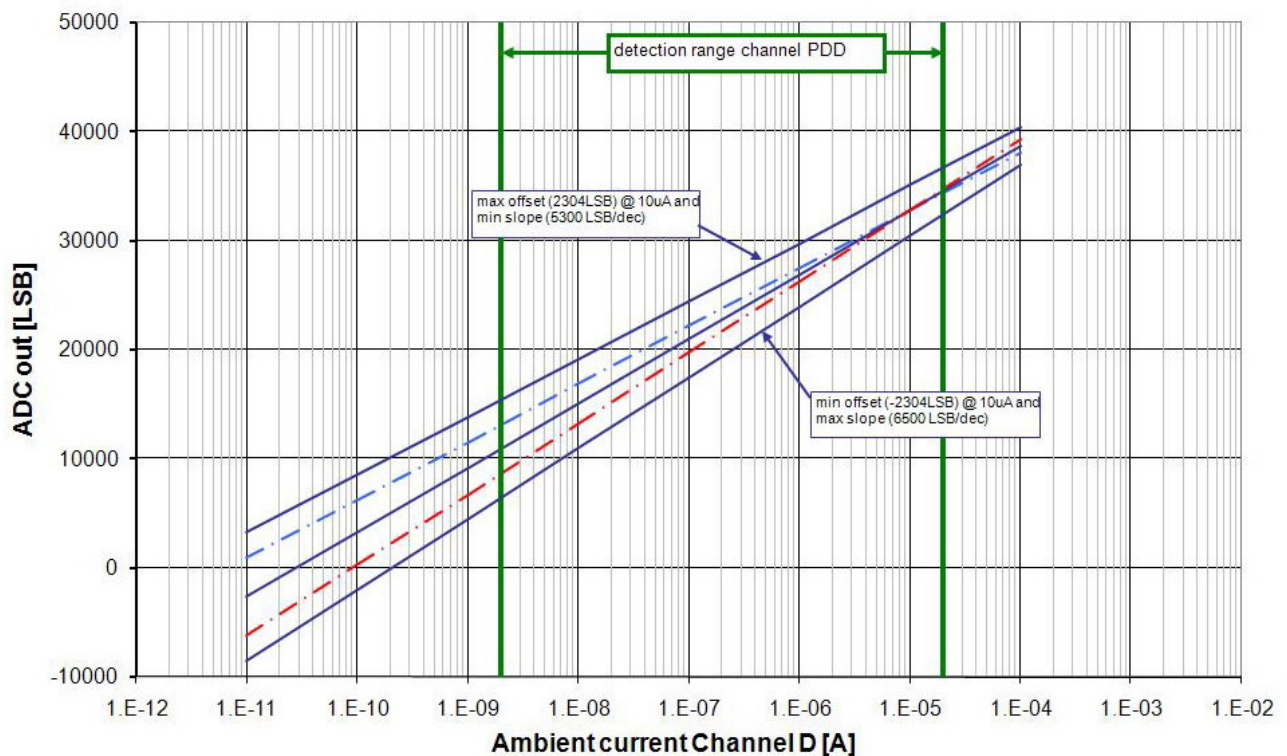
## 8.2. Ambient Light Sensor

### 8.2.1. Normal Operation

The ambient light detection system of the MLX75031 consists of two independent channels C & D and an on-chip controllable dedicated ground pin GNDAMB. GNDAMB is internally set to GNDA in normal operation. An external photodiode is connected in between each channel and GNDAMB. The Base-Emitter diode of a bipolar transistor generates a logarithmic transfer function from the incoming photocurrent to an internal voltage. Please refer to the MLX75031 EMC guidelines to improve the EMC resistance of the ambient channels

### 8.2.2. Logarithmic Transfer Function

Following graphs show the input current to output ADC value characteristic of each ambient channel.



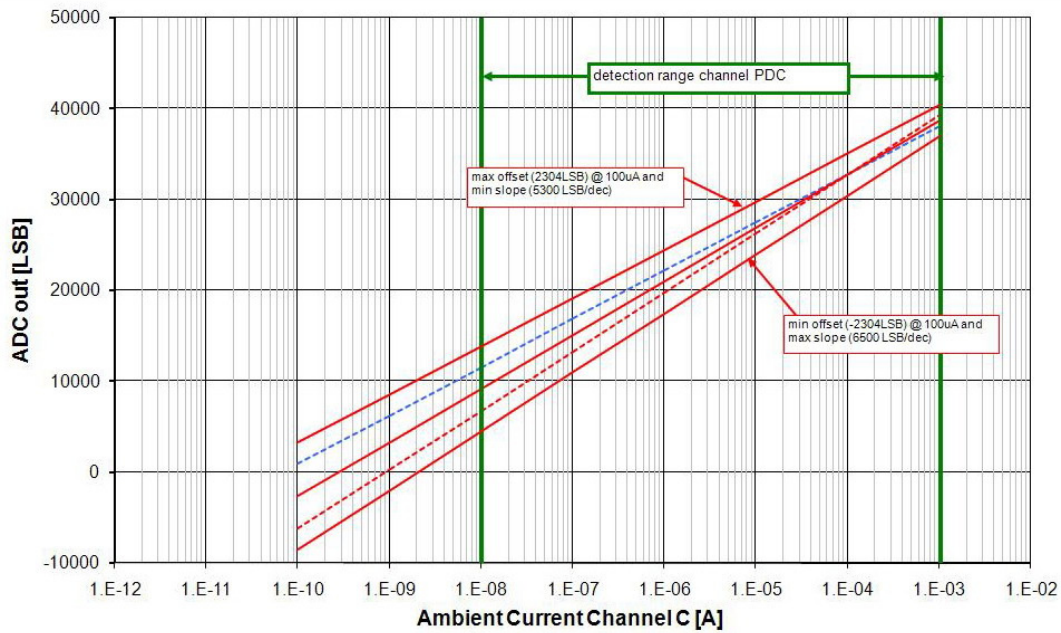


Figure 2: Input-to-output characteristic of each ambient channel at 3 different temperatures

### 8.2.3. Calibration & Temperature Compensation

The output of each ambient channel has a strong temperature dependence and a slight process dependence that can be compensated at run time. This is shown in following equation (channel x, x = C, D) :

$$I_x = (1 + TC_{I_{ref}} \Delta T) \left( 1 + \alpha \frac{O_x}{300^2} \Delta T \right) e^{\alpha \left( \frac{ambout_x - 2^{15}}{T} \right)} + \beta \quad (1)$$

- $I_x$ : calculated input light value
- $ambout_x$ : 16-bit ADC converted value of the ambient channel
- $TC_{I_{ref}}$ : temperature coefficient of the reference current (typ. Value = +1230ppm/K)
- $O_x$ : offset of the internal amplifiers (digital value)
- $\alpha_x, \beta_x$ : calibration values for channel x (see below)

During calibration at least 2 light levels ( $I_{x1}$  and  $I_{x2}$ ) have to be supplied to the target ambient channel (x) with its photodiode at the same known temperature T. The closer these values are chosen to the range used in application, the more accurate the final result will be. During the setting of these two light levels, the output of ambient channel x:  $ambout_{x1}$  and  $ambout_{x2}$  are measured. This results in 2 equations and 2 unknowns:  $\alpha_x$  and  $\beta_x$ . Both unknowns can be calculated from following formulas :

$$\alpha = \frac{T \ln\left(\frac{I_1}{I_2}\right)}{ambout_1 - ambout_2} \quad \text{and} \quad \beta = \ln\left(\frac{I_1}{1}\right) - \alpha \left( \frac{ambout_1 - 2^{15}}{T} \right) \quad (2)$$

Note : these 2 values automatically correct any gain error of the connected photodiode and used lens system.

After the calibration step, some error remains when the temperature deviates from the calibration temperature. The error depends on the temperature drift of the reference current ( $TC_{I_{ref}}\Delta T$ ) and on the offset  $O_x$ . In second order, it also depends on the temperature drift of gain G and of the offset  $O_x$ .

With  $TC_{I_{ref}} = +1230$  ppm/K, the ambient current calculation error because of the temperature drift of  $I_{ref}$  is from -10% at low temperature to +10% at high temperature.

The offset of the ambient signal conditioning chain is between 0 and -20mV (400 LSB). The corresponding temperature coefficient would be between 0 and -670 ppm/°C. The corresponding error in the ambient light calculation would be from 0 to -5.3%.

To reduce the MCU load a simple lookup table can be implemented instead of the complete formula.

## 8.2.4. Response Time

During operation, each ambient channel constantly shows a logarithmic output response towards the input current that is applied. As a result, the time for the output to respond on a changing input current is defined by a strongly non-linear function (similar but not equal to an RC-curve). Therefore a threshold crossing criterion is used to define the time response.

The light threshold level is defined as a border between light and dark. This threshold can be defined as a light level of a voltage level at the output of the ambient light channel. If the light suddenly crosses the defined light threshold, the output of the ambient light channel will cross the corresponding voltage threshold with a delay. This delay is the response time.

Figure 3 shows an example of such a threshold crossing. An input current step is used as this represents the worst case condition. Note that starting from an input current level that is close to the threshold, the end requirement of 20% below or 80% above can be heavily relaxed.

The ambient light response time is valid for any threshold level equal to or above the defined input threshold level  $I_{ambx\_detect}$  of any input channel.

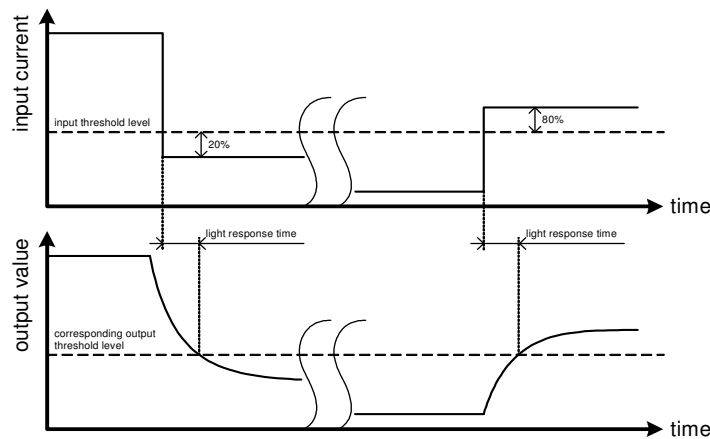


Figure 3 : Ambient response time explanation

## 8.2.5. Diagnostics Mode Operation

In diagnostics mode, the status of the external photodiodes is checked.

A set of switches controls the different possible error conditions by running through the different tests. At the end of this check, all switches go back into the initial position to allow normal ambient light detection.

Table 11 lists the possible error modes for detector C and pin GNDAMB.

The error modes for detectors D are equivalent.

| Failure                         | Detected    | How  |
|---------------------------------|-------------|--|
| detC disconnected               | Diagnostics | If checkC == 0: error!   |
| GNDAMB disconnected             | Diagnostics | Identical test as detC disconnected.   |
| detC shorted to GND/GNDD/GNDAMB | normal mode | <ul style="list-style-type: none"> <li>Ambient detector shows incredible high light input</li> <li>ADC response is much likely saturated, anyway the output is far beyond the allowed operation range</li> </ul>   |
|                                 | Diagnostics | If checkC == 0: error!   |
| detC shorted to VCCA/VCCD       | Diagnostics | If checkC == 1: error!   |
| GNDAMB shorted to GND/GNDD      | Various     | <ul style="list-style-type: none"> <li>This is no problem for normal operation</li> <li>This CAN be a problem in testmode if short is strong and pin GNDAMB pulled to VDDA: a maximum current of 50mA can be pulled during 10μs</li> <li>If so, test for detC disconnected will show an error</li> </ul> |
| GNDAMB shorted to VCCA/VCCD     | normal mode | A maximum current of 800mA can be pulled from this driver  |
|                                 | Diagnostics | If the current can be supplied by the module, an error will be flagged similar to detC shorted to VCCA/VCCD  |
| detC shorted to detD            | Diagnostics | <ul style="list-style-type: none"> <li>If checkC == 0: error!</li> <li>If checkD == 1: error!</li> </ul>   |

Table 11 : List of possible failures on the ambient pins – projected on channel C.

Note that in spite of the ability to detect any error by the ambient diagnostics, an error on an ambient pin might still have other unwanted effects.

•

- Shorting any channel to GNDA/GNDD/GNDAMB will make the readout of the whole ambient block useless. At this time a maximum current of 14mA might be constantly pulled from the supply, independent of the amount of channels that is shorted to GNDA/GNDD/GNDAMB.
- During normal operation, node GNDAMB should be considered a ground pin. Shorting this pin to any other voltage might result in a shortcurrent of max 800mA!
- Because of such unwanted effects, a detection of an error in diagnostics mode should be followed by a disabling of the ambient channels in order to avoid disturbing the operation of other blocks in the system.
- Note that unused channels should be connected with an external resistance ( $\sim 60\text{k}\Omega$ ) to GNDAMB. Doing so will avoid disturbing the other channels, but will give a constant error on the channel connected to GNDAMB.

### 8.3. Temperature Sensor

The on-chip temperature sensor measures the IC temperature. The output voltage of the sensor is converted by the 16-bit ADC. The sensor will be trimmed for the best result during the production. This trimming value is not applied to the temperature sensor internally, but is available to the customer through two on-chip registers Calib1 and Calib2, see 0. The Calib1 register contains the slope of the temperature curve in LSB/K. The Calib2 register contains the offset of the curve at a defined temperature at which the chip is tested in production. An exemplary plot for the temperature sensor is given in Figure 4 : Temperature sensor exemplary graph.

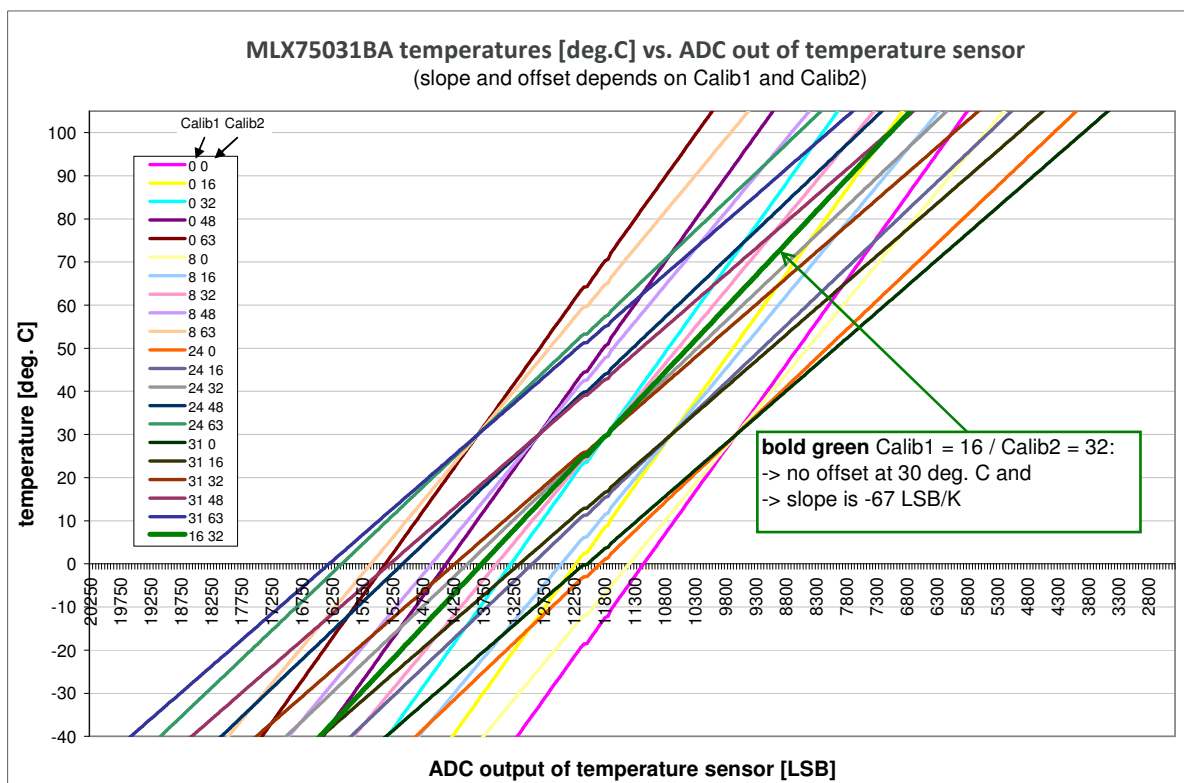


Figure 4 : Temperature sensor exemplary graph

The temperature is calculated from the temperature readout (*tempout*) and the gain and offset calibration data (calibration data measured at 30°C) according to the formula :

$$T_K = 303.15K + \frac{(11781 + 67(calib2 - 32)) - tempout}{67 + (calib1 - 16)} K$$

or in °C:

$$T = 30^{\circ}C + \frac{(11781 + 67(calib2 - 32)) - tempout}{67 + (calib1 - 16)} ^{\circ}C$$

- tempout : digital temperature readout (16Bit)
- calib1 : contents of calib1 register (5Bit)
- calib2 : contents of calib2 register (6Bit)

## 8.4. Analog to Digital Conversion

The ADC converts all MUX signals in a 16 bit word which is passed in a register in the digital block and can be read out through the SPI interface.

## 8.5. Output Stage

### 8.5.1. DAC

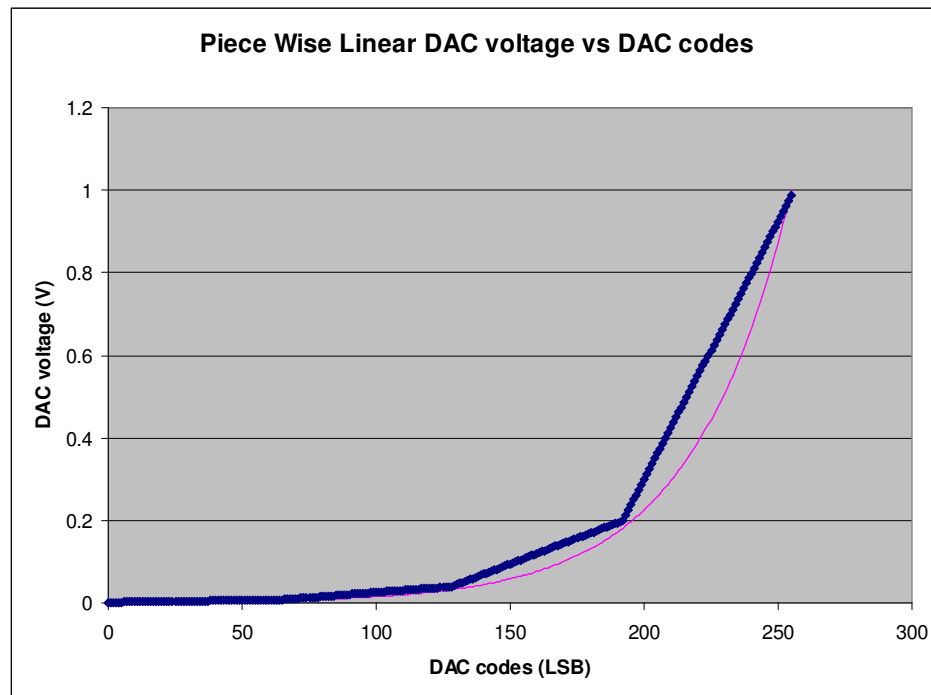
For the MLX75031 Active Light application, the DAC has been designed to generate a pulse voltage signal from 1mV to 1V, so that LED current driven by the LED driver can be 1mA to 150mA, if a 6.6Ω external resistor is used.

A logarithmic DAC was used.

A piece-wise linear DAC with four zones is implemented as approximation for the logarithmic DAC.

| DAC piece<br>(DACx[7:6]) | Steps in<br>each piece<br>(6LSBs<br>DACx[5:0] ) | Step size<br>for 1 bit (V) | Trasfer function<br>Vdac (V) =   | Range<br>start (V) | Range<br>end (V) |
|--------------------------|---|----------------------------|----------------------------------|--------------------|------------------|
| 00                       | 64  | 1.00E-04                   | 1.00E-04 * DACx[7:0] + 1.03E-3   | 1.03E-03           | 7.43E-03         |
| 01                       | 64  | 5.10E-04                   | 5.10E-04 * DACx[7:0] - 2.491E-2  | 7.56E-03           | 3.952E-02        |
| 10                       | 64  | 2.52E-03                   | 2.52E-03 * DACx[7:0] - 2.820E-01 | 4.022E-02          | 1.988E-01        |
| 11                       | 64  | 1.224E-02                  | 1.224E-02 * DACx[7:0] - 2.145    | 2.057E-01          | 9.769E-01        |

Table 12 : The DAC voltage values based on the DAC codes (DACx[7:0], x=A or B) at VDD=3.3V



*Figure 5 : Piece Wise Linear DAC voltage vs DAC codes*

### 8.5.2. LED Driver

The LED driver mainly contains one operational amplifier and transistors able to drive the external LEDs. Its task is to set the voltage over the external Rshunt equal to the voltage generated by DAC, so the corresponded current ( $V_{dac}/R_{shunt}$ ) is flowing through LED.

The error flag Err\_Drv is set high if the LED current regulation loop is broken (disconnected LED or shunt resistor).

### 8.5.3. LED Forward Voltage Measurement

When the current pulse is flowing through the LED, the voltage drop across the LED (between pin Drive\_LED A/B and pin ShuntR) is sampled and then held for later ADC conversion.

This value can be used to estimate the LED temperature.

The sampling occurs synchronously with the Active Light signal sampling.

The overall transfer function for the LED temperature sensing is defined by following formula:

$$V_{LED} = \frac{(ADC\_LEDTEMP - 32768) \times 6.64}{65535 \times G\_ADJ\_LED} + 2 \times OS\_ADJ\_LED$$

- $V_{LED}$ : the voltage between pin Drive\_LED A/B and pin ShuntR (in V)
- ADC\_LEDTEMP: the decimal value of the LED temperature measurement (see Output Data Frame of read-out)
- G\_ADJ\_LED: the gain value selected by the SetPLS register
- OS\_ADJ\_LED: the offset value selected by the SetPLS register (in V)

Due to different LED types and LED connections, the gain G\_ADJ\_LED and OS\_ADJ\_LED shall be set such that the measurement range fits the application the best way.

Minimum  $V_{LED}$  measurement resolution is typical 0.5mV.

### 8.5.4. Battery Supply Voltage Measurement & Monitoring

The voltage on the VSUP pin is continuously monitored. In case the voltage on the pin goes above 20V typical, the error flag Err\_VsupH will be set and the LED driver will be shut off. Active Light measurements can still be executed but the LED driver will be disabled as long as VSUP > 20V typical, protecting the LED's from being damaged.

The error flag Err\_VsupL will be set when the voltage on VSUP goes below the threshold defined by the two bits VSUPLOW<1:0>. The LED driver will remain active. Active Light measurements are still possible.

In Figure 6 the definition of the thresholds is shown. It is indicated when the certain error conditions are present and when the error flags are set.

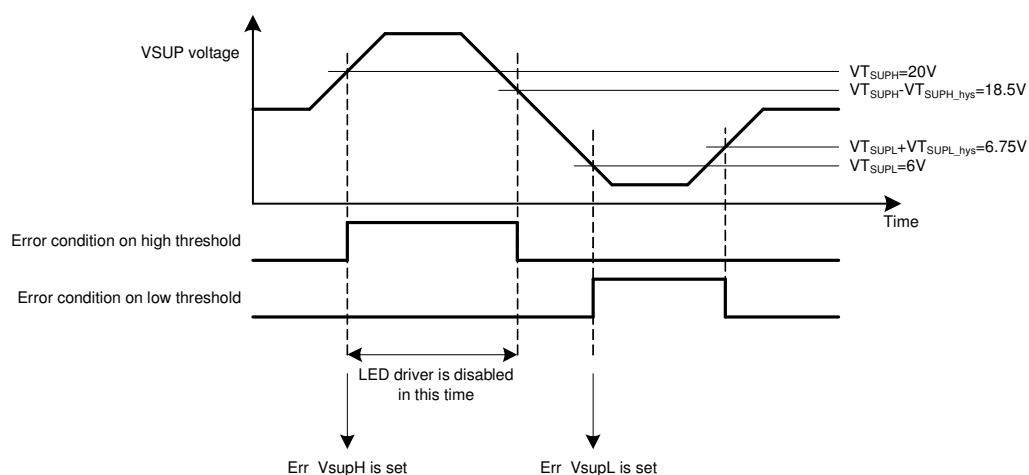


Figure 6 : Threshold definitions of VSUP monitoring block



Besides this continuous monitoring, it is possible to do a VSUP voltage measurement on request. This is included in the Measurement Sequence 1 of the Start Measurement command. Please refer to Section 8.11.4 for more information.

The overall transfer function for the VSUP measurement is defined by following formula :

$$V_{SUP} = \frac{16.6 \times ADC\_VSUP}{13107}$$

- $V_{SUP}$ : the voltage on the pin VSUP (in V)
- ADC\_VSUP: the decimal value of the VSUP measurement (see Output Data Frame of read-out)

## 8.6. Power-On Reset

The Power On Reset (POR) is connected to voltage supply. At power-on the POR cell generates a reset signal before the supply voltage exceeds a level of  $V_{POR-ON}$ . The cell contains a hysteresis of 100mV.

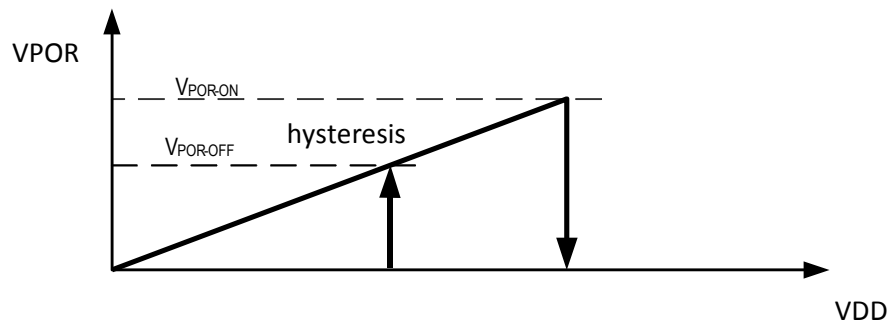


Figure 7 : POR sequence

## 8.7. Oscillator (RC)

The integrated oscillator has to provide a clock signal to the digital control logic, the watchdog timer and the ADC. The oscillator will run with a frequency at 2.5MHz, all other components with 1.25MHz. The drift of  $f_{osc}$  over temperature and supply voltage is smaller than 8%. The oscillator can be enabled and disabled when changing the modes (NRM/STBY –SLP). It is active in normal mode and in standby mode. In sleep mode, it is disabled.

## 8.8. ADC MUX

The ADC multiplexer transfers the various voltages of interest to the AD converter.

## 8.9. Vstab Analog +Bandgap

This block generates all reference voltages and current sources for the analogue blocks.

These sources work as far as possible independent from the temperature.

The block is also switched off in standby and sleep mode and has a wake up functionality with the smallest possible time.

## 8.10. Digital Control

The digital control is responsible for all clock and gating signals used within the IC. These signals control the LED drive sequence, the sampling and conversion of the photo-diode inputs, and so on.

The digital control is also responsible for channeling data to and from the SPI interface.

## 8.11. SPI

### 8.11.1. General Description of the SPI Interface

After power-on, the sensor enters a reset state (invoked by the internal power-on-reset circuit). A start-up time  $t_{startup}$  after power-on, the internal reference voltages have become stable and a first measurement cycle can start. To indicate that the start-up phase is complete, the DR pin will go high (DR is low during the start-up phase).

The control of this sensor is completely SPI driven. For each task to be executed, the proper command must be uploaded via the SPI. The SPI uses a four-wire communication protocol. The following pins are used:

**CS** : when CS pin is low, transmission and reception are enabled and the MISO pin is driven. When the CS pin goes high, the MISO pin is no longer driven and becomes a floating output. This makes it possible that one micro-processor takes control over multiple sensors by setting the CS pin of the appropriate sensor low while sending commands. The idle state of the chip select is high.

**SCLK** : clock input for the sensor. The clock input must be running only during the upload of a new command or during a read-out cycle. The idle state of the clock input is high.

**MOSI** : data input for uploading the different commands and the data that needs to be written into some registers. The idle state of the data input is low.

**MISO** : data output of the sensor.

A SPI timing diagram is given in Figure 8. This is the general format for sending a command. First the CS pin must be set low so that the sensor can accept data. The low level on the CS pin in combination with the first rising clock edge is used to start an internal synchronization counter that counts the incoming bits. Data on the MOSI pin is clocked in at the rising clock edge. Data on the MISO pin is shifted out during the falling clock edge. Note that the tri-state of the MISO pin is controlled by the state of CS.

After uploading a command, the CS pin must be set high for a minimum time of  $t_{cs\_inter}$  in order to reset the internal synchronization counter and to allow new commands to be interpreted.

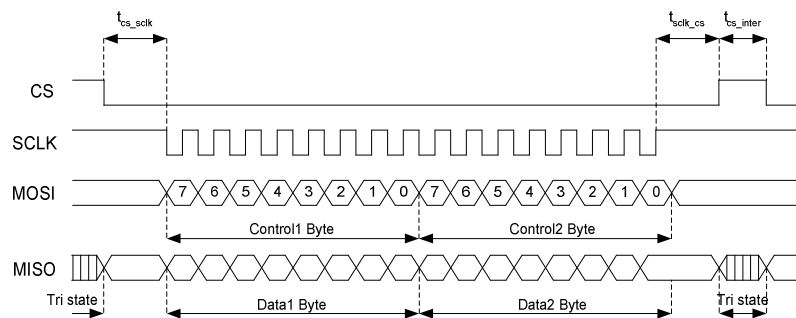


Figure 8 : SPI Timing Diagram for 2 byte instructions

The basic structure of a command consists of 2 bytes: the Control1 Byte and the Control2 Byte that are uploaded to the device and the Data1 Byte and the Data2 Byte that are downloaded to the micro-controller. Exceptions are the commands needed to read and write the user registers (WR/RR). These commands need 3 bytes. The timing diagram is given in Figure 9.

All data transfer happens with MSB first, LSB last. Referring to Figure 8 and Figure 9 within a byte, bit 7 is always defined as the MSB, bit 0 is the LSB. This applies to all data transfers from master to slave and vice versa.

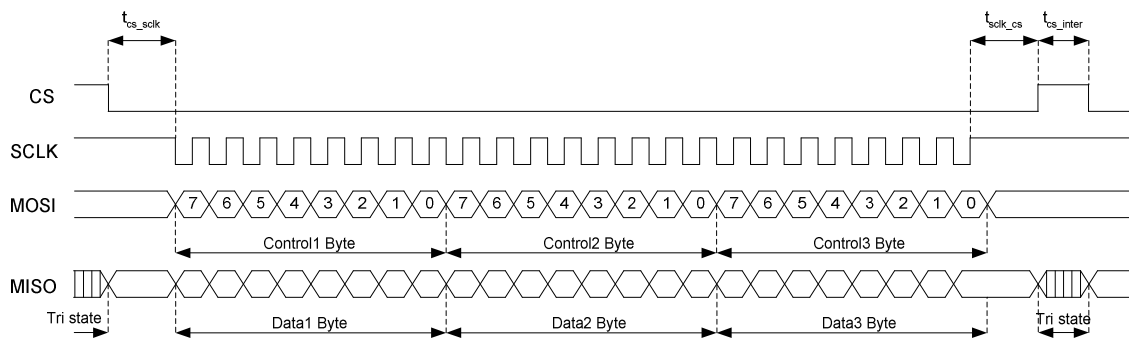


Figure 9 : SPI Timing Diagram for 3 byte instructions

The MSB of the Control1 Byte (bit 7) is a command token: setting this bit to 1 means that the Control1 Byte will be interpreted as a new command. If the MSB is 0, the next bits are ignored and no command will be accepted. The idle command has a Control1 Byte of 0x00.

The command type (chip reset, watchdog trigger, power mode change, start measurements, start read-out, read/write register) is selected with the next bits 6..0 of the Control1 Byte.

The Control2 Byte consists of 0x00, to allow clocking out the Data2 Byte. The Data2 Byte contains always the Ctrl1 Byte that was uploaded. Thus the micro-controller can check that the Data2 Byte is an exact replica of the Ctrl1 Byte, to verify that the right command is uploaded to the device.

The Data1 Byte contains some internal status flags to allow checking the internal state of the device. The internal status flags are defined in the table below (Table 13). See section 0 for more information concerning the operation of the status flags.

| Status flag | Status when bit is set   | Status when bit is clear                      |
|-------------|--|---|
| Bit 7 (MSB) | Previous Command was invalid   | Previous Command was valid                    |
| Bit 6..5    | Power State:<br>11 = (reserved)<br>10 = Normal Running Mode<br>01 = Stand-by State<br>00 = Sleep State |   |
| Bit 4       | Sleep Request was sent   | No Sleep Request available                    |
| Bit 3       | Standby Request was sent   | No Standby Request available                  |
| Bit 2       | Device is in TestMode  | Device is not in TestMode                     |
| Bit 1       | Internal Oscillator is enabled (Standby Mode or Normal Running Mode)                                   | Internal Oscillator is shut down (Sleep Mode) |
| Bit 0 (LSB) | Critical Error occurred  | No Error is detected                          |

*Table 13 : Internal Status Flags as given in the Data1 Byte*

Table 14 summarizes the instruction set of the sensor. A detailed explanation of these different commands is given in Section 8.11.3.

| Symbol | Command Description | Control1 Byte | Control2 Byte     | Control3 Byte |
|--------|---------------------|---------------|-------------------|---------------|
| NOP    | Idle Command        | 0000 0000     | 0000 0000         | N/A           |
| CR     | Chip Reset          | 1111 0000     | 0000 0000         | N/A           |
| WDT    | Watchdog Trigger    | 1001 0011     | 0000 0000         | N/A           |
| RSLP   | Request Sleep       | 1110 0001     | 0000 0000         | N/A           |
| CSLP   | Confirm Sleep       | 1010 0011     | 0000 0000         | N/A           |
| RSTBY  | Request Standby     | 1110 0010     | 0000 0000         | N/A           |
| CSTBY  | Confirm Standby     | 1010 0110     | 0000 0000         | N/A           |
| NRM    | Normal Running Mode | 1110 0100     | 0000 0000         | N/A           |
| SM     | Start Measurement   | 1101 00R0T    | M6..M3<br>M2M1M0P | N/A           |
| SD     | Start Diagnostics   | 1011 0000     | 0000 0000         | N/A           |
| RO     | Start Read-Out      | 1100 0011     | 0000 0000         | N/A           |
| WR     | Write Register      | 1000 0111     | D7..D0            | A3..A0 P1P000 |
| RR     | Read Register       | 1000 1110     | A3..A0 0000       | 0000 0000     |

*Table 14 : Instruction set of the Active Light sensor*

Besides the above instruction set, there are some test commands available for production test purposes. To prevent unintentional access into these test modes, it requires multiple commands before the actual test mode is entered.



## 8.11.3. Detailed Explanation of SPI Instruction Words

### 8.11.3.1. NOP – Idle Command

The Idle Command can be used to read back the internal status flags that appear in the Data1 Byte. The state of the device is not changed after the NOP command is uploaded.

### 8.11.3.2. CR – Chip Reset Command

After upload of a Chip Reset command, the sensor returns to a state as it is after power-up (Normal Running Mode) except for the watchdog counter, the state of the *MR* line and the contents of the 'Rst' register. The watchdog counter, the 'Rst' register and the state of the *MR* line will not be influenced by a CR command.

The CR command can be uploaded at any time, even during a measurement or a read-out cycle, provided that the internal synchronization counter is reset. This is done by setting the CS pin high for at least a time  $t_{cs\_inter}$ .

When a CR command is uploaded during sleep mode resp. standby mode, the device goes automatically into normal running mode. Note that this requires a time  $t_{wakeup\_slp}$  resp.  $t_{wakeup\_stby}$  before the internal analog circuitry is fully set up again.

Right after upload of a CR command, the *DR* pin will go low during a time  $t_{startup}$ . Once the wake-up/reset phase is complete, the *DR* pin will go high.

### 8.11.3.3. RSLP/CSLP – Request Sleep/Confirm Sleep

To avoid that the slave device goes unintentionally into sleep mode, the master has to upload two commands. First a RSLP (Request Sleep) shall be uploaded, then the slave sets bit 4 of the internal status flag byte high. The master has to confirm the sleep request by uploading a CSLP (Confirm Sleep). Afterwards the slave will go into Sleep Mode, hereby reducing the current consumption, and the pin *SLEEPB* will switch to low indicating that the device state changed into Sleep mode.

The pin *SLEEPB* will change state a time  $t_{sleepb}$  after the pin CS is set high at the end of the CSLP command.

The status flag can be cleared by uploading a CR command or a NRM command.

Note that uploading a Chip Reset makes the device switching into normal running mode.

The state of the *DR* pin will not be changed when going into Sleep Mode. However, after a wake-up event the *DR* pin is set low during a time  $t_{wakeup\_slp}$ .

#### 8.11.3.4. RSTBY/CSTBY - Request Standby/Confirm Standby

To put the device in Standby Mode, a similar system is used: the master shall send the RSTBY command, requesting the slave to go into Standby Mode. The slave device sets bit 3 of the internal status flag byte high, indicating that it wants to go into standby. The master has to confirm this by sending the CSTBY byte. The pin *SLEEPB* will be set low a time  $t_{\text{sleepb}}$  after the pin *CS* is set high at the end of the CSTBY command.

The status flag can be cleared by uploading a CR command or a NRM command.  
Note that uploading a Chip Reset makes the device switching into normal running mode.

The state of the DR pin will not be changed when going into Standby Mode. However, after a wake-up event the DR pin is set low during a time  $t_{\text{wake\_up\_stby}}$ .

#### 8.11.3.5. NRM – Normal Running Mode

The NRM command shall be used to wake up the device from Sleep Mode, or to go from Standby into Normal Running Mode. This requires a time  $t_{\text{wake\_up\_slp}}$  resp.  $t_{\text{wake\_up\_stby}}$  before the internal analog circuitry is fully set up again. The NRM will also clear the Sleep Request or Standby Request flag.

When the device wakes up from Standby or Sleep mode, the pin *SLEEPB* will go high, to indicate that the device state changed into Normal Running Mode. The  $t_{\text{sleepb}}$  time is not applicable in case of wake-up.

When the NRM command is uploaded during normal running mode, the state of the device will not be influenced, except when the Sleep Request or Standby Request flag was set high due to a RSLP or RSTBY command. In this case, the Sleep Request or Standby Request flag will be cleared; the state of the DR pin will not change.

## 8.11.4. SM – Start Measurement

The SM command is used to start up measurement cycles.

Two different Measurement Sequences can be selected with option bit  $M_6$ :

- setting  $M_6$  high enables the Measurement Sequence 1, wherein the two Ambient Light Channels, the die temperature and the voltage on the  $VSUP$  pin are measured
- setting  $M_6$  low enables the Measurement Sequence 2, wherein the DC Light, the Active Light, the LED Temperature and the voltage on the  $VSUP$  pin during the Active Light pulse are measured. When  $M_6$  is set low, 4 other option bits are available in order to select the LED that needs to be fired and to select the Active Light channel that needs to be read out:
  - $M_3$ : setting this bit high fires LED A and measures the temperature of LED A
  - $M_2$ : setting this bit high fires LED B and measures the temperature of LED B
  - $M_1$ : setting this bit high enables the Active Light measurement in channel A
  - $M_0$ : setting this bit high enables the Active Light measurement in channel B

The table below gives the overview of available options bits in the SM command.

| Control2 Bits          | Measurement Sequence 1   | Measurement Sequence 2   |
|------------------------|--|--|
| $M_6$                  | Set to 1   | Set to 0   |
| $M_5$                  | Set to 0   | Set to 0   |
| $M_4$                  | Set to 0   | Set to 0   |
| $M_3$                  | Set to 0   | 1 = Fire + Measure Temperature of LED A<br>0 = Don't fire + Measure Temperature of LED A   |
| $M_2$                  | Set to 0   | 1 = Fire + Measure Temperature of LED B<br>0 = Don't fire + Measure Temperature of LED B   |
| $M_1$                  | Set to 0   | 1 = Measure Active Light on Channel A<br>0 = Don't measure Active Light on Channel A   |
| $M_0$                  | Set to 0   | 1 = Measure Active Light on Channel B<br>0 = Don't measure Active Light on Channel B   |
| Available Measurements | Die temperature<br>Ambient light channel C<br>Ambient light channel D<br>Battery voltage | DC light before Active Light pulse<br>Battery voltage during Active Light pulse<br>Active Light measurements<br>Temperature of LED |

*Table 15 : Available option bits in SM Command*

A typical timing diagram is given in Figure 11. After uploading the SM command, the measurement cycle is started as soon as the  $CS$  pin is set high. The ADC starts converting all the needed analog voltages and stores the digital values in registers.

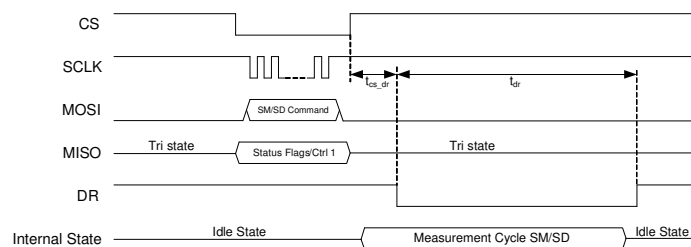
A time  $t_{cs\_dr}$  after  $CS$  is set high, the state of the  $DR$  pin goes low. A time  $t_{dr}$  after  $DR$  was set low, the state of the  $DR$  pin becomes high, indicating that all measurements are completed and that the resulted data is available for read-out (read-back of the stored data in the registers). This time can be up to 239us, if an internal auto-zeroing process is under execution and needs to be finished.



*Table 16 : Basic Measurement Execution Times tdr*

| Measurement Type   | Min. tdr (μs) | Max. tdr (μs) |
|--|---------------|---------------|
| Measurement Sequence 1   | 520           | 611           |
| Measurement Sequence 2: measure one Active Light channel with typical Tdc_pulse<1:0> and typical TP<2:0> settings  | 786           | 924           |
| Measurement Sequence 2: measure one Active Light channel with maximum Tdc_pulse<1:0> and maximum TP<2:0> settings  | 1024          | 1203          |
| Measurement Sequence 2: measure two Active Light channels with typical Tdc_pulse<1:0> and typical TP<2:0> settings | 921           | 1082          |
| Measurement Sequence 2: measure two Active Light channels with maximum Tdc_pulse<1:0> and maximum TP<2:0> settings | 1159          | 1361          |

**Note :** the *DR* pin can be used as an interrupt for the master device as it indicates when a read-out cycle can be started.



*Figure 11 : Timing Diagram of a Measurement Cycle*

The SM command contains 2 option bits: R0 & T. The bit R0 sets the polarity of the ADC input buffer in Active Light channels A & B. The bit T provides test pulses during the Active Light measurements.

- R0: Inversion of the offset of the ADC\_buffer. The output will change from (Signal + Offset\_opamp\_buf) to (Signal - offset\_opamp\_buf). In this way, by processing 2 measurements with inverted R0 bits, the offset of the ADC buffer filter can be cancelled.
- T: This bit replaces the light pulses by internal current pulses during the Active Light measurements. The LED driver will not be activated when this option bit is selected.

The SM command contains an option bit T. If this bit is set to 0, normal Active Light measurements are performed (i.e. the external LED's are fired and the Active Light channels A and/or B are measured). If this bit is set to 1, no LED's are fired, but an internal test pulse is applied to channels A and/or B. The internal test pulse can be influenced in amplitude by the bits DACA7 and DACA6 (when LED A is fired) or by the bits DACB7 and DACB6 (when LED B is fired).

| DACA7/<br>DACB7 | DACA6/<br>DACB6 | I_Testpulse [uA] | Typical ADC value [LSB] at<br>default TP & Gain settings |
|-----------------|-----------------|------------------|--|
| 0               | 0               | 5                | 8466   |
| 0               | 1               | 13               | 14737  |
| 1               | 0               | 21               | 20967  |
| 1               | 1               | 29               | 27195  |

*Table 17 : Current levels for Active Light testmode.*

In the Control2 byte an even parity bit P is foreseen. The parity bits calculation is based on the measurement selection bits  $M_6..M_0$ . If the number of ones in the given data set  $[M_6..M_0]$  is odd, the even parity bit P shall be set to 1, making the total number of ones in the set  $[M_6..M_0, P]$  even. The SPI invalid flag will be set when the parity bit does not correspond to the calculated parity bit.

After upload of a SM/SD command, no other commands will be accepted till *DR* is high. This is done to avoid too much disturbances in the analog part. Once *DR* is high, the next command will be accepted. An exception however is the Chip Reset command. This will always be accepted.

Note : none of the SM/SD commands are available in Standby and Sleep Mode.

### 8.11.5. RO – Start Read-Out

When the state of the *DR* pin changed into a high state, the measurement data is available for read-out. The RO command shall be uploaded to start a read-out cycle and to start reading out the data that was stored in the internal registers.

To make sure that no memory effects can occur, all data registers are cleared at the end of each read-out cycle.

A typical timing diagram is given in Figure 12 below:

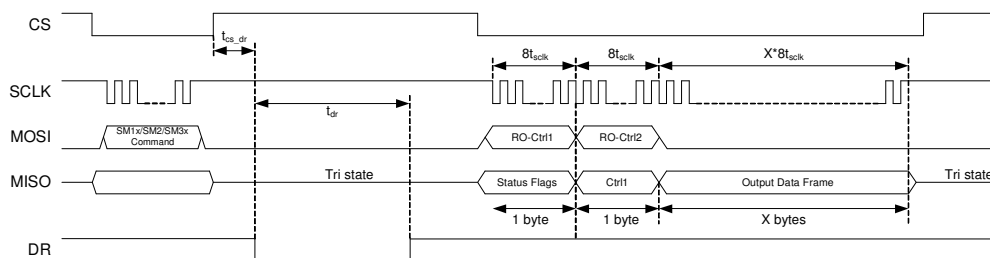


Figure 12 : Timing diagram for Read-Out

Note : the RO command is not available in Standby and Sleep Mode.

The data that appears on the *MISO* pin depends on the type of measurement that was done (i.e. it depends on the command that was uploaded: SM/SD and the selected option bits  $M_6..M_0$ ).

The table below shows the Output Data Frame when Measurement Sequence 1 is selected :

| Data Byte Number | Output Data Frame Contents - Measurement Sequence 1 | Comments              |
|------------------|---|-----------------------|
| Byte 3           | Die Temperature Measurement (8 MSB)                 | Depends on EN_TEMP    |
| Byte 4           | Die Temperature Measurement (8 LSB)                 | Depends on EN_TEMP    |
| Byte 5           | Ambient light \ channel C measurement (8 MSB)       | Depends on EN_CH_C    |
| Byte 6           | Ambient light channel C measurement (8 LSB)         | Depends on EN_CH_C    |
| Byte 7           | Ambient light channel D measurement (8 MSB)         | Depends on EN_CH_D    |
| Byte 8           | Ambient light channel D measurement (8 LSB)         | Depends on EN_CH_D    |
| Byte 9           | Internally Reserved Register                        | Reserved              |
| Byte 10          | Internally Reserved Register                        | Reserved              |
| Byte 11          | Battery Voltage Measurement (8 MSB)                 | Depends on EN_VSUPMON |
| Byte 12          | Battery Voltage Measurement (8 LSB)                 | Depends on EN_VSUPMON |
| Byte 13          | CRC (8 bit)   | Output always         |

*Table 18 : SM Output Data Frame - Measurement Sequence 1*

The table below shows the Output Data Frame when Measurement Sequence 2 is selected :

| Data Byte Number | Output Data Frame Contents - Measurement Sequence 2           | Comments  |
|------------------|---|---|
| Byte 3           | DC measurement of IR channel A (8 MSB)                        | Depends on M1 + on EN_CH_A                                  |
| Byte 4           | DC measurement of IR channel A (8 LSB)                        | Depends on M1 + on EN_CH_A                                  |
| Byte 5           | DC measurement of IR channel B (8 MSB)                        | Depends on M0 + on EN_CH_B                                  |
| Byte 6           | DC measurement of IR channel B (8 LSB)                        | Depends on M0 + on EN_CH_B                                  |
| Byte 7           | Battery voltage measurement during Active Light pulse (8 MSB) | Depends on EN_VSUPMON                                       |
| Byte 8           | Battery voltage measurement during Active Light pulse (8 LSB) | Depends on EN_VSUPMON                                       |
| Byte 9           | Active Light measurement of IR channel A (8 MSB)              | Depends on M1 + on EN_CH_A + LED selection depends on M3/M2 |
| Byte 10          | Active Light measurement of IR channel A (8 LSB)              | Depends on M1 + on EN_CH_A + LED selection depends on M3/M2 |
| Byte 11          | Active Light measurement of IR channel B (8 MSB)              | Depends on M0 + on EN_CH_B + LED selection depends on M3/M2 |
| Byte 12          | Active Light measurement of IR channel B (8 LSB)              | Depends on M0 + on EN_CH_B + LED selection depends on M3/M2 |

|         |   |  |
|---------|---|--|
| Byte 13 | Temperature of LED that was fired (8 MSB) | Depends on EN_LEDSENS + LED selection depends on M3/M2 |
| Byte 14 | Temperature of LED that was fired (8 LSB) | Depends on EN_LEDSENS + LED selection depends on M3/M2 |
| Byte 15 | CRC (8 bit)                               | Output always  |

*Table 19 : SM Output Data Frame - Measurement Sequence 2*

When certain measurement blocks are disabled, the corresponding data bytes are omitted from the Output Data Frame.

### Cyclic Redundancy Check Calculation

In all Output Data Frames, a CRC byte is included as last byte. This byte provides a way to detect transmission errors between slave and master. An easy method to check if there were no transmission errors is to calculate the CRC of the whole read-out frame as defined in previous tables. When the calculated CRC results in 0x00, the transmission was error free. If the resulting CRC is not equal to zero, then an error occurred in the transmission and all the data should be ignored.

For more information regarding the CRC calculation, please refer to Section 8.18.

## 8.11.6. DM+RO - Start Measurement combined with Read-Out

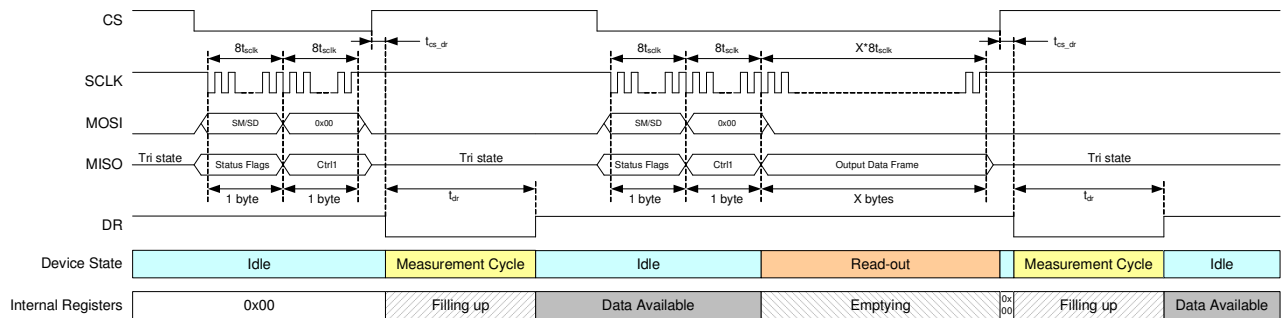
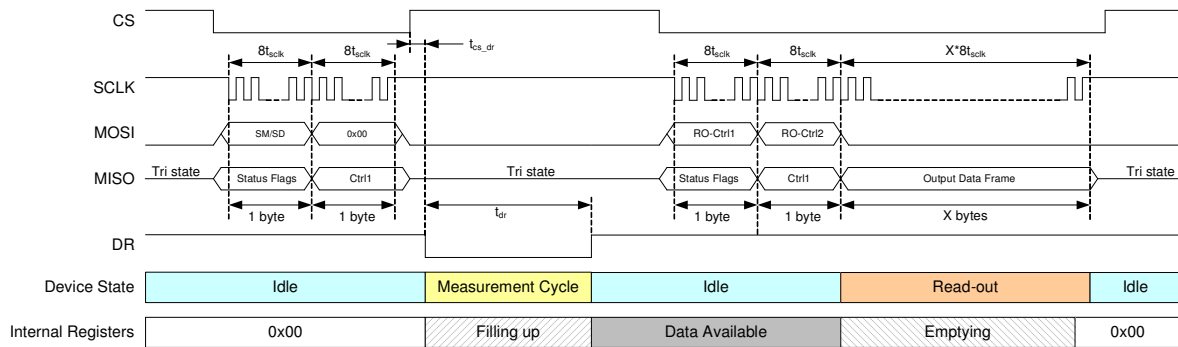
If after upload of the SM command, extra clocks are given (without putting CS high!), the data stored in the internal registers will appear on the MISO pin. At the end of the read-out phase the internal registers will be cleared to avoid memory effects in the next read-outs.

The newly uploaded SM command will be executed after the read-out, when the CS pin goes high.

The two figures below show the difference between the two modes of operation:

- Figure 13 shows the operation with separate SM and RO commands. After upload of a SM command, the measurement cycle will start and the internal registers will be filled. Once the DR pin is high, the RO command can be uploaded to start the read-out cycle. All data of the internal registers will be transferred and at the end of the read-out the registers will be cleared.

- Figure 14 shows the operation with the combined SM and RO. First one has to upload a SM command to start a measurement. The data is available for read-out when the DR pin goes high. Instead of uploading a RO command, a SM command can be uploaded again to combine read-out and the start of the next measurement cycle. If extra clocks are given after upload of the SM command, the data of the internal registers becomes available on the MISO pin. Note that the CS pin shall not be set high until the read-out is finished. Once CS pin goes high, the DR pin is set low and a new measurement cycle will be started. A time  $t_{dr}$  later the DR pin goes high to indicate that the data is available.



### 8.11.7. WR/RR - Write/Read Register

The slave contains several user registers that can be read and written by the master. The WR and RR commands are used for that.

The WR command writes the contents of an 8-bit register addressed by bits  $A_{3..0}$  with data  $D_{7..0}$ . Data is sent to the device over the *MOSI* pin. Control2 Byte contains the 8 bit data that shall be written into the target register. Control3 Byte contains the address of the target register. The WR command is defined in the table below:

| Control1 Byte                         | Control2 Byte  | Control3 Byte   |
|---------------------------------------|--|-----------------|
| 1000 0111                             | D7D6D5D4 D3D2D1D0  | A3A2A1A0 P1P000 |
| D7D6D5D4 D3D2D1D0<br>A3A2A1A0<br>P1P0 | Data contents of register to be written<br>Address of target register<br>Parity bits (P1 = odd parity bit, P0 = even parity bit) |                 |
| Data1 Byte                            | Data2 Byte   | Data3 Byte      |
| Status Flag Byte                      | 1000 0111  | 0000 0000       |

Table 20 : Write Register command

In order to detect some transmission errors while writing data towards the slave device, the micro-controller has to compute an odd and an even parity bit of the Control2 and the 4 MSB's of the Control3 byte and send these parity bits to the slave. The slave will check if the parity bits are valid. The data will only be written into the registers if the parity bits are correct. If the parity bits are not correct, bit 7 of the internal Status Flag Byte will be set high, indicating that the command was invalid. This can be seen when uploading a NOP command (when one is only interested in reading back the internal status flags) or during upload of the next command.

In case the parity bits were not correct, the data of the registers will not be changed.

The parity bits calculation is based on the data  $D_7..D_0$  and  $A_3..A_0$ . If the number of ones in the given data set  $[D_7..D_0, A_3..A_0]$  is odd, the even parity bit  $P_0$  shall be set to 1, making the total number of ones in the set  $[D_7..D_0, A_3..A_0, P_0]$  even.

Similar: if the number of ones in the given data set  $[D_7..D_0, A_3..A_0]$  is even, the odd parity bit  $P_1$  shall be set to 1, making the total number of ones in the set  $[D_7..D_0, A_3..A_0, P_1]$  odd.

Note that the parity bits can be generated with XOR instructions:  $P_1 = \text{XNOR}(D_7..D_0, A_3..A_0)$  and  $P_0 = \text{XOR}(D_7..D_0, A_3..A_0)$ . The odd parity bit  $P_1$  should always be the inverse of the even parity bit  $P_0$ .

The RR command returns the contents of an 8-bit register addressed by bits  $A_3..A_0$ . Data is read back over the MISO pin. The Data1 Byte contains the Internal Status Flag byte. Data2 Byte contains the copy of the Control1 Byte. Data3 Byte contains the 8 bits of the target register.

The RR command is defined in the table below:

| Control1 Byte    | Control2 Byte                  | Control3 Byte     |
|------------------|--------------------------------|-------------------|
| 1000 1110        | A3A2A1A0 0000                  | 0000 0000         |
| A3A2A1A0         | Address of target register     |                   |
| Data1 Byte       | Data2 Byte                     | Data3 Byte        |
| Status Flag Byte | 1000 1110                      | D7D6D5D4 D3D2D1D0 |
| D7..0            | Data contents of register read |                   |

*Table 21 : Read Register command*

Note : WR and RR commands are commands that require 3 bytes instead of 2 bytes.

More information concerning the user registers can be found in Section 0.

### 8.11.8. SD – Start Diagnostics

The SD command will start a measurement cycle in which internal signals will be measured and converted. With this command it is possible to test some circuits in the chip and check if they are functioning as expected.

The SD command behaves in much the same way as the SM commands: instead of uploading a SM command, a SD command can be uploaded. This starts the measurement cycle and conversion of some internal signals. The pin DR goes high when the cycle is completed, indicating that a read-out can be started. With the RO command it is possible to read out the data and check if all the data values are within certain ranges.

Datasheet

After upload of a SD command, no other commands will be accepted till DR is high. This is done to avoid too much disturbances in the analog part. Once DR is high, the next command will be accepted. An exception however is the Chip Reset command. This will always be accepted.

The SD command is not available in Standby Mode.

The execution time tdr for the diagnostics measurements is between 605µs and 712µs.

The Output Data Frame is defined in the table below :

| Data Byte Number | Data Byte Contents after SD command          |
|------------------|--|
| Byte 3           | ADCTest0 (8 MSB)                             |
| Byte 4           | ADCTest0 (8 LSB)                             |
| Byte 5           | ADCTest1 (8 MSB)                             |
| Byte 6           | ADCTest1 (8 LSB)                             |
| Byte 7           | ADCTest2 (8 MSB)                             |
| Byte 8           | ADCTest2 (8 LSB)                             |
| Byte 9           | ADCTest3 (8 MSB)                             |
| Byte 10          | ADCTest3 (8 LSB)                             |
| Byte 11          | DAC-ADC Test (8 MSB)                         |
| Byte 12          | DAC-ADC Test (8 LSB)                         |
| Byte 13          | 00000 + CDE Ambient Diodes Detection (3 bit) |
| Byte 14          | CRC (8 bit)                                  |

*Table 22 : SD Output Data Frame*

### ADCTest0/1/2/3

These measurements are AD conversions of some internal reference voltages:

- ADCTest0 is typically at 1/16 of the ADC range: ADCTest0 = 0x0E00 .. 0x1200.
- ADCTest1 is typically at 1/4=4/16 of the ADC range: ADCTest1 = 0x3E00 .. 0x4200.
- ADCTest2 is typically at 15/16 of the ADC range: ADCTest2 = 0xEE00 .. 0xF200.

ADCTest3 is similar to ADCTest0/1/2: an AD conversion of an internal reference voltage is made. However, an independent voltage reference is used as input for the ADC in case of ADCTest3. In the case of ADCTest0/1/2, the reference voltages are generated from the references used for the ADC.

The typical output for ADCTest3 will be at half of the ADC range: ADCTest3 = 0x7888 .. 0x89D0. These values are valid for VDD=3.3V +/-2%.

### DAC-ADC test

A DAC-ADC test measurement is performed in the following way: the DAC output is connected to the ADC input. The DAC input will be DACA<7:0> from register 'SetAH'. This DAC-input will be converted to an analog output voltage that will be converted again by the ADC to give a digital value. This digital value is given in the bytes DAC-ADC Test. Note that the values written to DACA<7:0> should be limited to the range 0x80..0xFF during the DAC-ADC test.

Datasheet

In section Section 8.5.1 the typical DAC output voltage is given for a certain code, call this voltage  $V_{dac}$  (in V). Then the following formula applies:  $ADC\_out = 19721 \cdot V_{dac} + 32768$ , where  $ADC\_out$  is the decimal value of the DAC-ADC Test word in the Output Data Frame.

### Ambient Diodes Detection

During the Diagnostics measurement, the status of the external photo diodes connected to the ambient light channel inputs is checked.

Three bits b'CDE are output: when the bit C is set high, an error on the photodiode channel C is present. In a similar way, bits D and E indicate if errors on ambient light channels D and E are present or not.

## 8.12. Internal Status Flags

### Bit 7: Previous Command invalid/valid

When an uploaded command is considered invalid, bit 7 will be set high. This bit can be read out when the next command will be uploaded. If the next command is valid, bit 7 will be cleared again.

A command is considered invalid in case :

- a command is unknown (i.e. all commands that are not mentioned in Table 14)
- the parity bit in the SM or SD command is not correct
- the parity bits in a WR command are not correct
- when a command (except the CR command) was sent during a measurement cycle (i.e. after uploading a SM/SD command, when  $DR$  is still low)
- when a RO command was sent when  $DR$  is low (at any time, i.e. not only after uploading a SM/SD command)
- if a '1' is written into one of the bits of the 'Err' register
- if a WDT command is uploaded while the device is in Sleep Mode

### Bit 6..5: Power State, Bit 4: Sleep request, Bit 3: Standby request

The behaviour of the power state and the sleep request bits is explained in Figure 15.

First a RSLP command is uploaded to the sensor. As a result of that, the sensor will put the status flag bit 4 (sleep request flag) high. The master can read out that flag by uploading a NOP command, or when uploading other commands.

The master can confirm to go into sleep mode by uploading a CSLP command. The request flag will be reset and the sensor will switch into sleep state. The status flag bits 6 and 5 will be set accordingly.

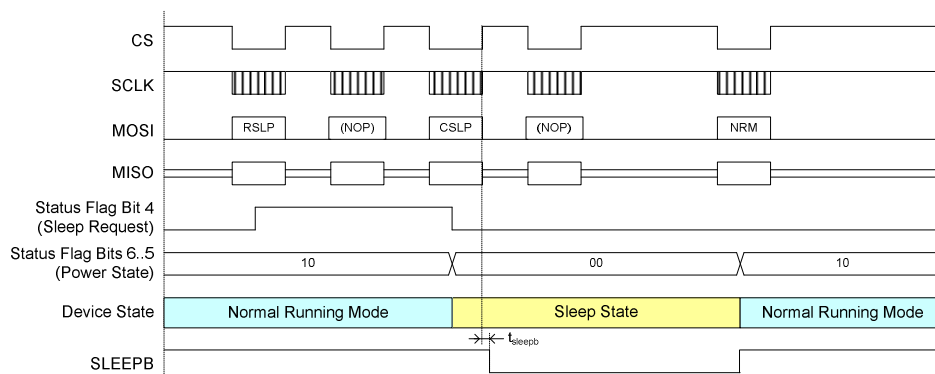


Figure 15 : Power State and Sleep Request bits



Datasheet

To go into standby mode, the same procedure shall be applied: uploading a RSTBY command makes the request standby flag going high. Uploading a CSTBY will make the device going into standby mode, whereby the request standby flag will be cleared and the power state bits will be set accordingly.

**Bit 2: Device in TestMode/Normal Mode**

To make the sensor efficiently testable in production, several test modes are foreseen to get easy access to different blocks. The status flag bit 2 indicates if the device is operating in Test Mode or Normal Mode. If the device enters test mode by accident, the application will still work like normal. However, the status flag bit 2 will be set high. The master can take actions to get out of test mode by uploading a CR command.

**Bit 1: Internal Oscillator is enabled/disabled**

This bit is high when the internal oscillator is enabled. Once the RCO is shut down the bit will be set low.

**Bit 0: Critical Error is detected/not detected**

During each measurement cycle there is a monitoring of the voltage on critical nodes along the analog paths. When the voltage of one of these controlled nodes goes out of its normal operating range, the Critical Error Flag will be set high.

Following nodes are monitored :

- TIA output: when the output is clipped (either high or low), the Critical Error Flag will be set high
- Difference between DAC output and shunt-feedback
- An internal reference voltage
- Output of the common mode SC-amplifiers of the Ambient Light/Temperature Channels
- Frequency on RCO output
- Voltage on the *VSUP* pin

In case the Critical Error Flag was set high, the 'Err' register indicates which node voltages got out of their normal operating range. More info about the 'Err' register can be found in Section 8.13.6.

The Critical Error Flag remains high as long as the 'Err' register is not cleared. Once the 'Err' register is cleared, the Critical Error Flag will be cleared as well.

Note : after POR, or after wake-up from Sleep/Standby, some bits in the 'Err' register might be set. As such the Critical Error Flag might be set as well.

## 8.13. User Registers Overview

| Name     | Address | Bit 7         | Bit 6         | Bit 5         | Bit 4         | Bit 3         | Bit 2      | Bit 1      | Bit 0      |
|----------|---------|---------------|---------------|---------------|---------------|---------------|------------|------------|------------|
| SetAna   | 0x0     | VSUPLOW1      | VSUPLOW0      | -             | -             | -             | Tdc_pulse1 | Tdc_pulse0 | Unity_Gain |
| SetAH    | 0x1     | DACA7         | DACA6         | DACA5         | DACA4         | DACA3         | DACA2      | DACA1      | DACA0      |
| SetAL    | 0x2     | GAIN_ADJ_A2   | GAIN_ADJ_A1   | GAIN_ADJ_A0   | -             | BW_ADJ_A1     | BW_ADJ_A0  | -          | -          |
| SetBH    | 0x3     | DACB7         | DACB6         | DACB5         | DACB4         | DACB3         | DACB2      | DACB1      | DACB0      |
| SetBL    | 0x4     | GAIN_ADJ_B2   | GAIN_ADJ_B1   | GAIN_ADJ_B0   | -             | BW_ADJ_B1     | BW_ADJ_B0  | -          | -          |
| SetTP    | 0x5     | -             | -             | EN_LEDSENS    | EN_VSUPMON    | -             | TP2        | TP1        | TP0        |
| Err      | 0x6     | Err_VsupH     | Err_TIA       | Err_Drv       | Err_Vref      | Err_Amb       | Err_RCO    | -          | Err_VsupL  |
| Rst      | 0x7     | -             | -             | -             | -             | TrimOk        | DieChip    | TO         | POR        |
| Version  | 0x8     | Ver3          | Ver2          | Ver1          | Ver0          | -             | -          | -          | -          |
| Reserved | 0x9     | -             | -             | -             | -             | -             | -          | -          | -          |
| GainBuf  | 0xA     | -             | -             | -             | GAIN_BUF4     | GAIN_BUF3     | GAIN_BUF2  | GAIN_BUF1  | GAIN_BUF0  |
| Calib1   | 0xB     | TRIM_T_SLOPE4 | TRIM_T_SLOPE3 | TRIM_T_SLOPE2 | TRIM_T_SLOPE1 | TRIM_T_SLOPE0 | -          | -          | -          |
| Calib2   | 0xC     | -             | -             | TRIM_TEMP5    | TRIM_TEMP4    | TRIM_TEMP3    | TRIM_TEMP2 | TRIM_TEMP1 | TRIM_TEMP0 |
| EnChan   | 0xD     | EN_TEMP       | EN_DIAG_A     | EN_DIAG_B     | EN_CH_A       | EN_CH_B       | EN_CH_C    | EN_CH_D    | -          |
| Tamb     | 0xE     | -             | -             | -             | -             | -             | -          | Tamb1      | Tamb0      |
| SetPLS   | 0xF     | OS_ADJ_LED1   | OS_ADJ_LED0   | G_ADJ_LED1    | G_ADJ_LED0    | -             | -          | Rise1      | Rise0      |

In the next sections, all the bits of these registers are described. The value of the register at Power-On is indicated in the line 'Init' (0 or 1 or x=unknown) and the read/write access ability is indicated in the line 'Read/Write' (R indicates Read access, W indicates Write access).

### 8.13.0. SetAna register

This register contains some settings of the analog chain.

| Bit                             |            | 7            | 6            | 5 | 4 | 3 | 2              | 1              | 0              |
|---------------------------------|------------|--------------|--------------|---|---|---|----------------|----------------|----------------|
| <b>SetAna</b><br><br><b>0x0</b> |            | VSUP<br>LOW1 | VSUP<br>LOW0 | - | - | - | Tdc_<br>pulse1 | Tdc_<br>pulse0 | Unity_<br>Gain |
|                                 | Read/Write | R/W          | R/W          | R | R | R | R/W            | R/W            | R/W            |
|                                 | Init       | 1            | 0            | 0 | 0 | 0 | 1              | 0              | 1              |

- VSUPLOW<1:0>: defines the threshold voltage at which the critical error flag Err\_VSupL is set

| VSUPLOW1 | VSUPLOW0 | VSUP Threshold (V) |
|----------|----------|--------------------|
| 0        | 0        | 5                  |
| 0        | 1        | 5.5                |
| 1        | 0        | 6                  |
| 1        | 1        | 6.5                |

- SetAna<5:3>: not implemented, read as '0'
- Tdc\_pulse<1:0>: defines the time that the DC component in the Active Light pulse signal is enabled before the actual Active Light pulses start. The time mentioned in the table below is the delay time as generated by the digital logic.

| Tdc_<br>pulse1 | Tdc_<br>pulse0 | Delay time<br>(in $\mu$ s, +/-8%) |
|----------------|----------------|-----------------------------------|
| 0              | 0              | 50                                |
| 0              | 1              | 100                               |
| 1              | 0              | 200                               |
| 1              | 1              | 400                               |

- Unity\_Gain: only during Active Light measurements: 1=ADC buffer is bypassed, 0=ADC gain stage is used (gain is set with bits GAIN\_BUF<4:0> in register 'GainBuf')

### 8.13.1. SetAH register

This register defines the DAC level for IR channel A.

|       |            | Bit   |       |       |       |       |       |       |       |
|-------|------------|-------|-------|-------|-------|-------|-------|-------|-------|
|       |            | 7     | 6     | 5     | 4     | 3     | 2     | 1     | 0     |
| SetAH |            | DACA7 | DACA6 | DACA5 | DACA4 | DACA3 | DACA2 | DACA1 | DACA0 |
| 0x1   | Read/Write | R/W   | R/W   | R/W   | R/W   | R/W   | R/W   | R/W   | R/W   |
|       | Init       | 0     | 0     | 0     | 0     | 0     | 0     | 0     | 0     |

- DACA<7:0>: the 8 bits of the DAC level for IR channel A

### 8.13.2. SetAL register

This register defines the gain and cut-off frequency adjustments for IR channel A.

|       |            | Bit         |             |             |   |           |           |   |   |
|-------|------------|-------------|-------------|-------------|---|-----------|-----------|---|---|
|       |            | 7           | 6           | 5           | 4 | 3         | 2         | 1 | 0 |
| SetAL |            | GAIN_ADJ_A2 | GAIN_ADJ_A1 | GAIN_ADJ_A0 | - | BW_ADJ_A1 | BW_ADJ_A0 | - | - |
| 0x2   | Read/Write | R/W         | R/W         | R/W         | R | R/W       | R/W       | R | R |
|       | Init       | 0           | 0           | 0           | 0 | 0         | 1         | 0 | 0 |

- GAIN\_ADJ\_A<2:0>: gain adjustment of channel A

| GAIN_ADJ_A2 | GAIN_ADJ_A1 | GAIN_ADJ_A0 | Gain |
|-------------|-------------|-------------|------|
| 0           | 0           | 0           | 3    |
| 0           | 0           | 1           | 5.8  |
| 0           | 1           | 0           | 8.7  |
| 0           | 1           | 1           | 11.5 |
| 1           | 0           | 0           | 14.4 |
| 1           | 0           | 1           | 17.1 |
| 1           | 1           | 0           | 20.3 |
| 1           | 1           | 1           | 22.5 |

- SetAL<4>: not implemented, read as '0'
- BW\_ADJ\_A<1:0>: cut-off frequency adjustment of channel A

| BW_ADJ_A1 | BW_ADJ_A0 | 3dB Cut-off Frequency (kHz) |
|-----------|-----------|-----------------------------|
| 0         | 0         | 15                          |
| 0         | 1         | 30                          |
| 1         | 0         | 45                          |
| 1         | 1         | 70                          |

- SetAL<1:0>: not implemented, read as '0'

### 8.13.3. SetBH register

This register defines the DAC level for IR channel B.

| Bit          |            | 7     | 6     | 5     | 4     | 3     | 2     | 1     | 0     |
|--------------|------------|-------|-------|-------|-------|-------|-------|-------|-------|
| <b>SetBH</b> |            | DACB7 | DACB6 | DACB5 | DACB4 | DACB3 | DACB2 | DACB1 | DACB0 |
| <b>0x3</b>   | Read/Write | R/W   | R/W   | R/W   | R/W   | R/W   | R/W   | R/W   | R/W   |
|              | Init       | 0     | 0     | 0     | 0     | 0     | 0     | 0     | 0     |

- DACB<7:0>: the 8 bits of the DAC level for IR channel B

### 8.13.4. SetBL register

This register defines the gain and cut-off frequency adjustments for IR channel B.

| Bit          |            | 7           | 6           | 5           | 4 | 3         | 2         | 1 | 0 |
|--------------|------------|-------------|-------------|-------------|---|-----------|-----------|---|---|
| <b>SetBL</b> |            | GAIN_ADJ_B2 | GAIN_ADJ_B1 | GAIN_ADJ_B0 | - | BW_ADJ_B1 | BW_ADJ_B0 | - | - |
| <b>0x4</b>   | Read/Write | R/W         | R/W         | R/W         | R | R/W       | R/W       | R | R |
|              | Init       | 0           | 0           | 0           | 0 | 0         | 1         | 0 | 0 |

- GAIN\_ADJ\_B<2:0>: gain adjustment of channel B

| GAIN_ADJ_B2 | GAIN_ADJ_B1 | GAIN_ADJ_B0 | Gain |
|-------------|-------------|-------------|------|
| 0           | 0           | 0           | 3    |
| 0           | 0           | 1           | 5.8  |
| 0           | 1           | 0           | 8.7  |
| 0           | 1           | 1           | 11.5 |
| 1           | 0           | 0           | 14.4 |
| 1           | 0           | 1           | 17.1 |
| 1           | 1           | 0           | 20.3 |
| 1           | 1           | 1           | 22.5 |

- SetBL<4>: not implemented, read as '0'
- BW\_ADJ\_B<1:0>: cut-off frequency adjustment of channel B

| BW_ADJ_B1 | BW_ADJ_B0 | 3dB Cut-off Frequency (kHz) |
|-----------|-----------|-----------------------------|
| 0         | 0         | 15                          |
| 0         | 1         | 30                          |
| 1         | 0         | 45                          |
| 1         | 1         | 70                          |

- SetBL<1:0>: not implemented, read as '0'

### 8.13.5. SetTP register

This register contains some enable signals and defines the pulse duration setting for the Active Light measurements.

| Bit          |            | 7 | 6 | 5              | 4              | 3 | 2   | 1   | 0   |
|--------------|------------|---|---|----------------|----------------|---|-----|-----|-----|
| <b>SetTP</b> |            | - | - | EN_LEDS<br>ENS | EN_VSUP<br>MON | - | TP2 | TP1 | TP0 |
| <b>0x5</b>   | Read/Write | R | R | R/W            | R/W            | R | R/W | R/W | R/W |
|              | Init       | 0 | 0 | 1              | 1              | 0 | 0   | 1   | 1   |

- SetTP<7:6>: not implemented, read as '0'
- EN\_LEDSSENS: 1 = enables LED temperature sensing, 0 = disables LED temperature sensing
- EN\_VSUPMON: 1 = enables voltage monitoring on VSUP, 0 = disables voltage monitoring on VSUP
- TP<2:0>: pulse duration selection for the Active Light measurements, as defined below :

| Bit 2 - TP2 | Bit 1 - TP1 | Bit 0 - TP0 | Pulse width (+/- 8%) |
|-------------|-------------|-------------|----------------------|
| 0           | 0           | 0           | 4 $\mu$ s            |
| 0           | 0           | 1           | 9.6 $\mu$ s          |
| 0           | 1           | 0           | 14.4 $\mu$ s         |
| 0           | 1           | 1           | 19.2 $\mu$ s         |
| 1           | 0           | 0           | 24 $\mu$ s           |
| 1           | 0           | 1           | 29.6 $\mu$ s         |
| 1           | 1           | 0           | 49.6 $\mu$ s         |
| 1           | 1           | 1           | 79.2 $\mu$ s         |

Note : the target pulse width's to be used are: 14.4, 19.2, 24 and 29.6  $\mu$ s.

The smaller and the larger pulse width's are available for engineering purposes only. For the smaller pulse width's the settling of the LED driver is not guaranteed. For the larger pulse width's the thermal behaviour is not guaranteed.

### 8.13.6. Err register

As described in Section 0 (under section 'Bit 0: Critical Error is detected/not detected'), the voltages on critical nodes are monitored continuously. When a voltage on such a critical node goes outside its operating range, the Critical Error Flag and the appropriate error bit in the 'Err' register will be set high. As such, the source of the error can be found in the 'Err' register.

The error bit remains high as long as the error condition is present, or as long as the error bit is not cleared (in case the error condition is not present anymore).

| Bit        |            | 7         | 6       | 5       | 4        | 3       | 2       | 1 | 0         |
|------------|------------|-----------|---------|---------|----------|---------|---------|---|-----------|
| <b>Err</b> |            | Err_VsupH | Err_TIA | Err_Drv | Err_Vref | Err_Amb | Err_RCO | - | Err_VsupL |
| <b>0x6</b> | Read/Write | R/W*      | R/W*    | R/W*    | R/W*     | R/W*    | R/W*    | R | R/W*      |
|            | Init       | x**       | 0       | 0       | x**      | x**     | x**     | 0 | x**       |

The following bits are defined (0= no error detected; 1=error is detected) :

- Err\_VsupH: critical error detected on battery supply voltage: VSUP > 20V typical. As long as VSUP > 20V typical, the LED driver will be shut off to avoid damaging the LED's. Measurement data should be discarded in this situation.
- Err\_TIA: critical error detected on TIA output
- Err\_Drv: critical error detected on the difference between DAC output and shunt-feedback
- Err\_Vref: critical error detected on internal voltage reference: when the internal voltage reference is below 1V.
- Err\_Amb: critical error detected on one of the common mode SC-filters of the ambient light/temperature channels
- Err\_RCO: critical error detected on RCO: either a stuck-at-high or a stuck-at-low condition occurred at the output of the RCO. Note that in SLP, the error flag on the RCO will be set high.
- Err<1>: not implemented, read as '0'
- Err\_VsupL: critical error detected on battery supply voltage: VSUP < 6V typical (default). Note that this threshold is programmable with 2 bits VSUPLOW<1:0>).

\* : only writing '0' is allowed. If a '1' is written, the bit value in the register will not be changed, but Bit 7 of the Internal Status Flags will be set high (Previous Command Invalid).

\*\* : 'x' indicates that the value after POR is unknown. If the voltages of the nodes are out of range right after POR, it will be immediately reflected in the 'Err' register and the Critical Error Flag will be set. The same is valid after wake-up from Sleep/Standby.

### 8.13.7. Rst register

This register allows differentiation of either a POR or a reset due to a watchdog time-out + settings for the PD compensation circuitry.

| Bit                      |            | 7  | 6  | 5  | 4  | 3      | 2       | 1  | 0   |
|--------------------------|------------|----|----|----|----|--------|---------|----|-----|
| <b>Rst</b><br><b>0x7</b> |            | -  | -  | -  | -  | TrimOK | DieChip | TO | POR |
|                          | Read/Write | R- | R- | R- | R- | R      | R       | R  | R/W |
|                          | Init       | 0  | 0  | 0  | 0  | 1      | 0       | 0  | 1   |

- TrimOK: 1 if device passed both 105degC and m40degC test successfully, 0 if one of the tests is not passed successfully
- DieChip: 1 if die chipping is present, 0 if die chipping is not present. Note that DieChip will only be valid during NRM.
- TO: 1=a Watchdog time-out and a master reset occurred. 0=no Watchdog time-out occurred, or after Power-On, or after a WDT command
- POR: 1=a POR occurred, 0=a POR has not occurred. To detect subsequent Power-On-Resets, the POR-bit shall be cleared right after Power-On.

### 8.13.8. Version register

This register contains the actual device version + settings for the PD compensation circuitry.

| Bit                          |            | 7    | 6    | 5    | 4    | 3 | 2 | 1 | 0 |
|------------------------------|------------|------|------|------|------|---|---|---|---|
| <b>Version</b><br><b>0x8</b> |            | Ver3 | Ver2 | Ver1 | Ver0 | - | - | - | - |
|                              | Read/Write | R    | R    | R    | R    | R | R | R | R |
|                              | Init       | 0    | 0    | 0    | 1    | 0 | 0 | 0 | 0 |

- Ver<3:0>: indicates the device version (will be incremented at every design iteration)
  - A-version: Ver<3:0> = 4'b0001



## 8.10.9. Reserved register

This register is used for internal evaluation purposes.

## 8.10.10. GainBuf register

This register contains the gain settings of the ADC input buffer. The use of this buffer is depending on bit 'Unity\_Gain' in the register 'SetAna'. It is recommended to keep the GainBuf register to its default value. Please contact Melexis before changing it.

| Bit            |            | 7 | 6 | 5 | 4         | 3         | 2         | 1         | 0         |
|----------------|------------|---|---|---|-----------|-----------|-----------|-----------|-----------|
| <b>GainBuf</b> |            | - | - | - | GAIN_BUF4 | GAIN_BUF3 | GAIN_BUF2 | GAIN_BUF1 | GAIN_BUF0 |
|                | Read/Write | R | R | R | R/W       | R/W       | R/W       | R/W       | R/W       |
|                | Init       | 0 | 0 | 0 | 1         | 1         | 0         | 1         | 0         |

- GainBuf<7:5>: not implemented, read as '0'
- GAIN\_BUF<4:0>: defines the gain setting of the ADC input buffer

| GAIN_BUF4 | GAIN_BUF3 | GAIN_BUF2 | GAIN_BUF1 | GAIN_BUF0 | Gain |
|-----------|-----------|-----------|-----------|-----------|------|
| 0         | 0         | 0         | 0         | 1         | 2    |
| 0         | 0         | 0         | 1         | 0         | 1    |
| 0         | 0         | 0         | 1         | 1         | 0.67 |
| 0         | 0         | 1         | 0         | 0         | 0.5  |
| 0         | 0         | 1         | 0         | 1         | 0.4  |
| 0         | 0         | 1         | 1         | 0         | 0.33 |
| 0         | 0         | 1         | 1         | 1         | 0.29 |
| 0         | 1         | 0         | 0         | 0         | 0.25 |
| 0         | 1         | 0         | 0         | 1         | 0.22 |
| 0         | 1         | 0         | 1         | 0         | 0.2  |
| 1         | 0         | 0         | 0         | 1         | 10   |
| 1         | 0         | 0         | 1         | 0         | 5    |
| 1         | 0         | 0         | 1         | 1         | 3.33 |
| 1         | 0         | 1         | 0         | 0         | 2.5  |
| 1         | 0         | 1         | 0         | 1         | 2    |
| 1         | 0         | 1         | 1         | 0         | 1.67 |
| 1         | 0         | 1         | 1         | 1         | 1.43 |
| 1         | 1         | 0         | 0         | 0         | 1.25 |
| 1         | 1         | 0         | 0         | 1         | 1.11 |
| 1         | 1         | 0         | 1         | 0         | 1    |

### 8.13.11/12 Calib1/Calib2 register

These registers contain the calibration settings for the temperature sensor.

| Bit           |            | 7                 | 6                 | 5                 | 4                 | 3                 | 2 | 1 | 0 |
|---------------|------------|-------------------|-------------------|-------------------|-------------------|-------------------|---|---|---|
| <b>Calib1</b> |            | TRIM_<br>T_SLOPE4 | TRIM_<br>T_SLOPE3 | TRIM_<br>T_SLOPE2 | TRIM_<br>T_SLOPE1 | TRIM_<br>T_SLOPE0 | - | - | - |
|               | <b>0xB</b> | R                 | R                 | R                 | R                 | R                 | R | R | R |
|               | Init       | x                 | x                 | x                 | x                 | x                 | 0 | 0 | 0 |

- TRIM\_T\_SLOPE<4:0>: defines the slope of the temperature sensor
- Calib1<2:0>: not implemented, read as '0'

The Calib1 register is used to indicate the slope of the temperature sensor curve in LSB/Kelvin. The slope is calculated out of a 2-point measurement of the temperature curve and is permanently programmed in the OTP by means of a 5 Bit word and accessible via the Calib1 register, see Table 23.

| Calib1 - TRIM_T_SLOPE<4:0> |      |                       |     |       |                       |
|----------------------------|------|-----------------------|-----|-------|-----------------------|
| Dec                        | Bin  | Slope<br>(LSB/Kelvin) | Dec | Bin   | Slope<br>(LSB/Kelvin) |
| 0                          | 0    | -51                   | 16  | 10000 | -67                   |
| 1                          | 1    | -52                   | 17  | 10001 | -68                   |
| 2                          | 10   | -53                   | 18  | 10010 | -69                   |
| 3                          | 11   | -54                   | 19  | 10011 | -70                   |
| 4                          | 100  | -55                   | 20  | 10100 | -71                   |
| 5                          | 101  | -56                   | 21  | 10101 | -72                   |
| 6                          | 110  | -57                   | 22  | 10110 | -73                   |
| 7                          | 111  | -58                   | 23  | 10111 | -74                   |
| 8                          | 1000 | -59                   | 24  | 11000 | -75                   |
| 9                          | 1001 | -60                   | 25  | 11001 | -76                   |
| 10                         | 1010 | -61                   | 26  | 11010 | -77                   |
| 11                         | 1011 | -62                   | 27  | 11011 | -78                   |
| 12                         | 1100 | -63                   | 28  | 11100 | -79                   |
| 13                         | 1101 | -64                   | 29  | 11101 | -80                   |
| 14                         | 1110 | -65                   | 30  | 11110 | -81                   |
| 15                         | 1111 | -66                   | 31  | 11111 | -82                   |

Table 23 : 5-Bit temperature sensor slope information as it is stored in the calib1 register.

| Bit           |            | 7 | 6 | 5              | 4              | 3              | 2              | 1              | 0              |
|---------------|------------|---|---|----------------|----------------|----------------|----------------|----------------|----------------|
| <b>Calib2</b> |            | - | - | TRIM_<br>TEMP5 | TRIM_<br>TEMP4 | TRIM_<br>TEMP3 | TRIM_<br>TEMP2 | TRIM_<br>TEMP1 | TRIM_<br>TEMP0 |
|               | <b>0xC</b> | R | R | R              | R              | R              | R              | R              | R              |
|               | Init       | 0 | 0 | x              | x              | x              | x              | x              | x              |

- Calib2<7:6>: not implemented, read as '0'
- TRIM\_TEMP<5:0>: defines the calibration settings of the temperature sensor

The offset of the temperature curve is measured at one temperature (preferably 30degC) and permanently stored in the zenerzap OTP with 6 bit word length. This information is accessible via the Calib2 register, see Table 24.

| Calib2 - TRIM_TEMP<5:0> |        |               | Slope: -67LSB/K |          |         |         |          |         |
|-------------------------|--------|---------------|-----------------|----------|---------|---------|----------|---------|
|                         |        |               | 25degC          |          |         | 30degC  |          |         |
| Dec                     | Bin    | Offset (degC) | LSL             | expected | USL     | LSL     | expected | USL     |
| 1                       | 1      | -31           | 10005.5         | 10039    | 10072.5 | 9670.5  | 9704     | 9737.5  |
| 2                       | 10     | -30           | 10072.5         | 10106    | 10139.5 | 9737.5  | 9771     | 9804.5  |
| 3                       | 11     | -29           | 10139.5         | 10173    | 10206.5 | 9804.5  | 9838     | 9871.5  |
| 4                       | 100    | -28           | 10206.5         | 10240    | 10273.5 | 9871.5  | 9905     | 9938.5  |
| 5                       | 101    | -27           | 10273.5         | 10307    | 10340.5 | 9938.5  | 9972     | 10005.5 |
| 6                       | 110    | -26           | 10340.5         | 10374    | 10407.5 | 10005.5 | 10039    | 10072.5 |
| 7                       | 111    | -25           | 10407.5         | 10441    | 10474.5 | 10072.5 | 10106    | 10139.5 |
| 8                       | 1000   | -24           | 10474.5         | 10508    | 10541.5 | 10139.5 | 10173    | 10206.5 |
| 9                       | 1001   | -23           | 10541.5         | 10575    | 10608.5 | 10206.5 | 10240    | 10273.5 |
| 10                      | 1010   | -22           | 10608.5         | 10642    | 10675.5 | 10273.5 | 10307    | 10340.5 |
| 11                      | 1011   | -21           | 10675.5         | 10709    | 10742.5 | 10340.5 | 10374    | 10407.5 |
| 12                      | 1100   | -20           | 10742.5         | 10776    | 10809.5 | 10407.5 | 10441    | 10474.5 |
| 13                      | 1101   | -19           | 10809.5         | 10843    | 10876.5 | 10474.5 | 10508    | 10541.5 |
| 14                      | 1110   | -18           | 10876.5         | 10910    | 10943.5 | 10541.5 | 10575    | 10608.5 |
| 15                      | 1111   | -17           | 10943.5         | 10977    | 11010.5 | 10608.5 | 10642    | 10675.5 |
| 16                      | 10000  | -16           | 11010.5         | 11044    | 11077.5 | 10675.5 | 10709    | 10742.5 |
| 17                      | 10001  | -15           | 11077.5         | 11111    | 11144.5 | 10742.5 | 10776    | 10809.5 |
| 18                      | 10010  | -14           | 11144.5         | 11178    | 11211.5 | 10809.5 | 10843    | 10876.5 |
| 19                      | 10011  | -13           | 11211.5         | 11245    | 11278.5 | 10876.5 | 10910    | 10943.5 |
| 20                      | 10100  | -12           | 11278.5         | 11312    | 11345.5 | 10943.5 | 10977    | 11010.5 |
| 21                      | 10101  | -11           | 11345.5         | 11379    | 11412.5 | 11010.5 | 11044    | 11077.5 |
| 22                      | 10110  | -10           | 11412.5         | 11446    | 11479.5 | 11077.5 | 11111    | 11144.5 |
| 23                      | 10111  | -9            | 11479.5         | 11513    | 11546.5 | 11144.5 | 11178    | 11211.5 |
| 24                      | 11000  | -8            | 11546.5         | 11580    | 11613.5 | 11211.5 | 11245    | 11278.5 |
| 25                      | 11001  | -7            | 11613.5         | 11647    | 11680.5 | 11278.5 | 11312    | 11345.5 |
| 26                      | 11010  | -6            | 11680.5         | 11714    | 11747.5 | 11345.5 | 11379    | 11412.5 |
| 27                      | 11011  | -5            | 11747.5         | 11781    | 11814.5 | 11412.5 | 11446    | 11479.5 |
| 28                      | 11100  | -4            | 11814.5         | 11848    | 11881.5 | 11479.5 | 11513    | 11546.5 |
| 29                      | 11101  | -3            | 11881.5         | 11915    | 11948.5 | 11546.5 | 11580    | 11613.5 |
| 30                      | 11110  | -2            | 11948.5         | 11982    | 12015.5 | 11613.5 | 11647    | 11680.5 |
| 31                      | 11111  | -1            | 12015.5         | 12049    | 12082.5 | 11680.5 | 11714    | 11747.5 |
| 32                      | 100000 | 0             | 12082.5         | 12116    | 12149.5 | 11747.5 | 11781    | 11814.5 |
| 33                      | 100001 | 1             | 12149.5         | 12183    | 12216.5 | 11814.5 | 11848    | 11881.5 |
| 34                      | 100010 | 2             | 12216.5         | 12250    | 12283.5 | 11881.5 | 11915    | 11948.5 |
| 35                      | 100011 | 3             | 12283.5         | 12317    | 12350.5 | 11948.5 | 11982    | 12015.5 |
| 36                      | 100100 | 4             | 12350.5         | 12384    | 12417.5 | 12015.5 | 12049    | 12082.5 |
| 37                      | 100101 | 5             | 12417.5         | 12451    | 12484.5 | 12082.5 | 12116    | 12149.5 |
| 38                      | 100110 | 6             | 12484.5         | 12518    | 12551.5 | 12149.5 | 12183    | 12216.5 |
| 39                      | 100111 | 7             | 12551.5         | 12585    | 12618.5 | 12216.5 | 12250    | 12283.5 |
| 40                      | 101000 | 8             | 12618.5         | 12652    | 12685.5 | 12283.5 | 12317    | 12350.5 |
| 41                      | 101001 | 9             | 12685.5         | 12719    | 12752.5 | 12350.5 | 12384    | 12417.5 |

|    |        |    |         |       |         |         |       |         |
|----|--------|----|---------|-------|---------|---------|-------|---------|
| 42 | 101010 | 10 | 12752.5 | 12786 | 12819.5 | 12417.5 | 12451 | 12484.5 |
| 43 | 101011 | 11 | 12819.5 | 12853 | 12886.5 | 12484.5 | 12518 | 12551.5 |
| 44 | 101100 | 12 | 12886.5 | 12920 | 12953.5 | 12551.5 | 12585 | 12618.5 |
| 45 | 101101 | 13 | 12953.5 | 12987 | 13020.5 | 12618.5 | 12652 | 12685.5 |
| 46 | 101110 | 14 | 13020.5 | 13054 | 13087.5 | 12685.5 | 12719 | 12752.5 |
| 47 | 101111 | 15 | 13087.5 | 13121 | 13154.5 | 12752.5 | 12786 | 12819.5 |
| 48 | 110000 | 16 | 13154.5 | 13188 | 13221.5 | 12819.5 | 12853 | 12886.5 |
| 49 | 110001 | 17 | 13221.5 | 13255 | 13288.5 | 12886.5 | 12920 | 12953.5 |
| 50 | 110010 | 18 | 13288.5 | 13322 | 13355.5 | 12953.5 | 12987 | 13020.5 |
| 51 | 110011 | 19 | 13355.5 | 13389 | 13422.5 | 13020.5 | 13054 | 13087.5 |
| 52 | 110100 | 20 | 13422.5 | 13456 | 13489.5 | 13087.5 | 13121 | 13154.5 |
| 53 | 110101 | 21 | 13489.5 | 13523 | 13556.5 | 13154.5 | 13188 | 13221.5 |
| 54 | 110110 | 22 | 13556.5 | 13590 | 13623.5 | 13221.5 | 13255 | 13288.5 |
| 55 | 110111 | 23 | 13623.5 | 13657 | 13690.5 | 13288.5 | 13322 | 13355.5 |
| 56 | 111000 | 24 | 13690.5 | 13724 | 13757.5 | 13355.5 | 13389 | 13422.5 |
| 57 | 111001 | 25 | 13757.5 | 13791 | 13824.5 | 13422.5 | 13456 | 13489.5 |
| 58 | 111010 | 26 | 13824.5 | 13858 | 13891.5 | 13489.5 | 13523 | 13556.5 |
| 59 | 111011 | 27 | 13891.5 | 13925 | 13958.5 | 13556.5 | 13590 | 13623.5 |
| 60 | 111100 | 28 | 13958.5 | 13992 | 14025.5 | 13623.5 | 13657 | 13690.5 |
| 61 | 111101 | 29 | 14025.5 | 14059 | 14092.5 | 13690.5 | 13724 | 13757.5 |
| 62 | 111110 | 30 | 14092.5 | 14126 | 14159.5 | 13757.5 | 13791 | 13824.5 |
| 63 | 111111 | 31 | 14159.5 | 14193 | 14226.5 | 13824.5 | 13858 | 13891.5 |

| Calib2 - TRIM_TEMP |       |               | Slope: -67LSB/K |          |        |         |          |        |
|--------------------|-------|---------------|-----------------|----------|--------|---------|----------|--------|
|                    |       |               | 85degC          |          |        | 105degC |          |        |
| Dec                | Bin   | Offset (degC) | LSL             | expected | USL    | LSL     | expected | USL    |
| 1                  | 1     | -31           | 5985.5          | 6019     | 6052.5 | 4645.5  | 4679     | 4712.5 |
| 2                  | 10    | -30           | 6052.5          | 6086     | 6119.5 | 4712.5  | 4746     | 4779.5 |
| 3                  | 11    | -29           | 6119.5          | 6153     | 6186.5 | 4779.5  | 4813     | 4846.5 |
| 4                  | 100   | -28           | 6186.5          | 6220     | 6253.5 | 4846.5  | 4880     | 4913.5 |
| 5                  | 101   | -27           | 6253.5          | 6287     | 6320.5 | 4913.5  | 4947     | 4980.5 |
| 6                  | 110   | -26           | 6320.5          | 6354     | 6387.5 | 4980.5  | 5014     | 5047.5 |
| 7                  | 111   | -25           | 6387.5          | 6421     | 6454.5 | 5047.5  | 5081     | 5114.5 |
| 8                  | 1000  | -24           | 6454.5          | 6488     | 6521.5 | 5114.5  | 5148     | 5181.5 |
| 9                  | 1001  | -23           | 6521.5          | 6555     | 6588.5 | 5181.5  | 5215     | 5248.5 |
| 10                 | 1010  | -22           | 6588.5          | 6622     | 6655.5 | 5248.5  | 5282     | 5315.5 |
| 11                 | 1011  | -21           | 6655.5          | 6689     | 6722.5 | 5315.5  | 5349     | 5382.5 |
| 12                 | 1100  | -20           | 6722.5          | 6756     | 6789.5 | 5382.5  | 5416     | 5449.5 |
| 13                 | 1101  | -19           | 6789.5          | 6823     | 6856.5 | 5449.5  | 5483     | 5516.5 |
| 14                 | 1110  | -18           | 6856.5          | 6890     | 6923.5 | 5516.5  | 5550     | 5583.5 |
| 15                 | 1111  | -17           | 6923.5          | 6957     | 6990.5 | 5583.5  | 5617     | 5650.5 |
| 16                 | 10000 | -16           | 6990.5          | 7024     | 7057.5 | 5650.5  | 5684     | 5717.5 |
| 17                 | 10001 | -15           | 7057.5          | 7091     | 7124.5 | 5717.5  | 5751     | 5784.5 |
| 18                 | 10010 | -14           | 7124.5          | 7158     | 7191.5 | 5784.5  | 5818     | 5851.5 |
| 19                 | 10011 | -13           | 7191.5          | 7225     | 7258.5 | 5851.5  | 5885     | 5918.5 |
| 20                 | 10100 | -12           | 7258.5          | 7292     | 7325.5 | 5918.5  | 5952     | 5985.5 |
| 21                 | 10101 | -11           | 7325.5          | 7359     | 7392.5 | 5985.5  | 6019     | 6052.5 |

## Datasheet

|    |        |     |         |       |         |        |      |        |
|----|--------|-----|---------|-------|---------|--------|------|--------|
| 22 | 10110  | -10 | 7392.5  | 7426  | 7459.5  | 6052.5 | 6086 | 6119.5 |
| 23 | 10111  | -9  | 7459.5  | 7493  | 7526.5  | 6119.5 | 6153 | 6186.5 |
| 24 | 11000  | -8  | 7526.5  | 7560  | 7593.5  | 6186.5 | 6220 | 6253.5 |
| 25 | 11001  | -7  | 7593.5  | 7627  | 7660.5  | 6253.5 | 6287 | 6320.5 |
| 26 | 11010  | -6  | 7660.5  | 7694  | 7727.5  | 6320.5 | 6354 | 6387.5 |
| 27 | 11011  | -5  | 7727.5  | 7761  | 7794.5  | 6387.5 | 6421 | 6454.5 |
| 28 | 11100  | -4  | 7794.5  | 7828  | 7861.5  | 6454.5 | 6488 | 6521.5 |
| 29 | 11101  | -3  | 7861.5  | 7895  | 7928.5  | 6521.5 | 6555 | 6588.5 |
| 30 | 11110  | -2  | 7928.5  | 7962  | 7995.5  | 6588.5 | 6622 | 6655.5 |
| 31 | 11111  | -1  | 7995.5  | 8029  | 8062.5  | 6655.5 | 6689 | 6722.5 |
| 32 | 100000 | 0   | 8062.5  | 8096  | 8129.5  | 6722.5 | 6756 | 6789.5 |
| 33 | 100001 | 1   | 8129.5  | 8163  | 8196.5  | 6789.5 | 6823 | 6856.5 |
| 34 | 100010 | 2   | 8196.5  | 8230  | 8263.5  | 6856.5 | 6890 | 6923.5 |
| 35 | 100011 | 3   | 8263.5  | 8297  | 8330.5  | 6923.5 | 6957 | 6990.5 |
| 36 | 100100 | 4   | 8330.5  | 8364  | 8397.5  | 6990.5 | 7024 | 7057.5 |
| 37 | 100101 | 5   | 8397.5  | 8431  | 8464.5  | 7057.5 | 7091 | 7124.5 |
| 38 | 100110 | 6   | 8464.5  | 8498  | 8531.5  | 7124.5 | 7158 | 7191.5 |
| 39 | 100111 | 7   | 8531.5  | 8565  | 8598.5  | 7191.5 | 7225 | 7258.5 |
| 40 | 101000 | 8   | 8598.5  | 8632  | 8665.5  | 7258.5 | 7292 | 7325.5 |
| 41 | 101001 | 9   | 8665.5  | 8699  | 8732.5  | 7325.5 | 7359 | 7392.5 |
| 42 | 101010 | 10  | 8732.5  | 8766  | 8799.5  | 7392.5 | 7426 | 7459.5 |
| 43 | 101011 | 11  | 8799.5  | 8833  | 8866.5  | 7459.5 | 7493 | 7526.5 |
| 44 | 101100 | 12  | 8866.5  | 8900  | 8933.5  | 7526.5 | 7560 | 7593.5 |
| 45 | 101101 | 13  | 8933.5  | 8967  | 9000.5  | 7593.5 | 7627 | 7660.5 |
| 46 | 101110 | 14  | 9000.5  | 9034  | 9067.5  | 7660.5 | 7694 | 7727.5 |
| 47 | 101111 | 15  | 9067.5  | 9101  | 9134.5  | 7727.5 | 7761 | 7794.5 |
| 48 | 110000 | 16  | 9134.5  | 9168  | 9201.5  | 7794.5 | 7828 | 7861.5 |
| 49 | 110001 | 17  | 9201.5  | 9235  | 9268.5  | 7861.5 | 7895 | 7928.5 |
| 50 | 110010 | 18  | 9268.5  | 9302  | 9335.5  | 7928.5 | 7962 | 7995.5 |
| 51 | 110011 | 19  | 9335.5  | 9369  | 9402.5  | 7995.5 | 8029 | 8062.5 |
| 52 | 110100 | 20  | 9402.5  | 9436  | 9469.5  | 8062.5 | 8096 | 8129.5 |
| 53 | 110101 | 21  | 9469.5  | 9503  | 9536.5  | 8129.5 | 8163 | 8196.5 |
| 54 | 110110 | 22  | 9536.5  | 9570  | 9603.5  | 8196.5 | 8230 | 8263.5 |
| 55 | 110111 | 23  | 9603.5  | 9637  | 9670.5  | 8263.5 | 8297 | 8330.5 |
| 56 | 111000 | 24  | 9670.5  | 9704  | 9737.5  | 8330.5 | 8364 | 8397.5 |
| 57 | 111001 | 25  | 9737.5  | 9771  | 9804.5  | 8397.5 | 8431 | 8464.5 |
| 58 | 111010 | 26  | 9804.5  | 9838  | 9871.5  | 8464.5 | 8498 | 8531.5 |
| 59 | 111011 | 27  | 9871.5  | 9905  | 9938.5  | 8531.5 | 8565 | 8598.5 |
| 60 | 111100 | 28  | 9938.5  | 9972  | 10005.5 | 8598.5 | 8632 | 8665.5 |
| 61 | 111101 | 29  | 10005.5 | 10039 | 10072.5 | 8665.5 | 8699 | 8732.5 |
| 62 | 111110 | 30  | 10072.5 | 10106 | 10139.5 | 8732.5 | 8766 | 8799.5 |
| 63 | 111111 | 31  | 10139.5 | 10173 | 10206.5 | 8799.5 | 8833 | 8866.5 |

Table 24 : 6-Bit Temperature curve offset information for a typical slope of 67LSB/K.

### 8.13.13. EnChan register

This register contains bit to enable/disable Active Light and ambient light channels.

| Bit           |            | 7       | 6         | 5         | 4       | 3       | 2       | 1       | 0 |
|---------------|------------|---------|-----------|-----------|---------|---------|---------|---------|---|
| <b>EnChan</b> |            | EN_TEMP | EN_DIAG_A | EN_DIAG_B | EN_CH_A | EN_CH_B | EN_CH_C | EN_CH_D | - |
| <b>0xD</b>    | Read/Write | R/W     | R/W       | R/W       | R/W     | R/W     | R/W     | R/W     | R |
|               | Init       | 1       | 1         | 1         | 1       | 1       | 1       | 1       | 1 |

- EN\_TEMP: 1 = temperature channel is in use, 0 = temperature channel is not in use
- EN\_DIAG\_A: 1 = enables diagnostics on Active Light channel A, 0 = disables the diagnostics
- EN\_DIAG\_B: 1 = enables diagnostics on Active Light channel B, 0 = disables the diagnostics
- EN\_CH\_A: 1 = Active Light channel A is enabled (TIA + Filter), 0 = Active Light channel A is completely switched off to reduce current consumption
- EN\_CH\_B: 1 = Active Light channel B is enabled (TIA + Filter), 0 = Active Light channel B is completely switched off to reduce current consumption
- EN\_CH\_C: 1 = ambient light channel C is in use, 0 = ambient light channel C is not in use
- EN\_CH\_D: 1 = ambient light channel D is in use, 0 = ambient light channel D is not in use

The bits EN\_CH\_A/EN\_CH\_B can be used to switch off channels that are not needed, and thus reducing the current consumption. When going into Sleep or Standby the setting of these bits is ignored, all channels will be switched off independently of EN\_CH\_A/EN\_CH\_B.

The bits EN\_TEMP/EN\_CH\_C/EN\_CH\_D/EN\_CH\_E are used to indicate which channels are in use and which channels are not in use.

In case all EN\_CH\_C/D/E bits are set to zero, but an ambient measurement is requested, then the Command Invalid status flag will be set high. The measurement itself will not be executed.

### 8.13.14. Tamb register

This register contains settings for the PD compensation circuitry + controls the repetition rate of the auto-zero timer.

| Bit         |            | 7 | 6 | 5 | 4 | 3 | 2 | 1     | 0     |
|-------------|------------|---|---|---|---|---|---|-------|-------|
| <b>Tamb</b> |            | - | - | - | - | - | - | Tamb1 | Tamb0 |
| <b>0xE</b>  | Read/Write | R | R | R | R | R | R | R/W   | R/W   |
|             | Init       | 0 | 0 | 0 | 0 | 0 | 0 | 1     | 0     |

- Tamb<3:2>: not implemented, read as '0'
- Tamb<1:0>: controls the repetition rate of the auto-zero timer

| Tamb1 | Tamb0 | Repetition Rate (ms +/-8%) |
|-------|-------|----------------------------|
| 0     | 0     | 1.25                       |
| 0     | 1     | 2.5                        |
| 1     | 0     | 5                          |
| 1     | 1     | 10                         |

### 8.13.15. SetPLS register

This register provides parameters to set up the LED temperature sensing circuit and it defines the shape of the Active Light pulses.

| Bit           |            | 7                   | 6                   | 5                  | 4                  | 3 | 2 | 1     | 0     |
|---------------|------------|---------------------|---------------------|--------------------|--------------------|---|---|-------|-------|
| <b>SetPLS</b> |            | OS_<br>ADJ_<br>LED1 | OS_<br>ADJ_<br>LED0 | G_<br>ADJ_<br>LED1 | G_<br>ADJ_<br>LED0 | - | - | Rise1 | Rise0 |
| <b>0xF</b>    | Read/Write | R/W                 | R/W                 | R/W                | R/W                | R | R | R/W   | R/W   |
|               | Init       | 0                   | 1                   | 0                  | 0                  | 0 | 0 | 1     | 0     |

- OS\_ADJ\_LED<1:0>: input offset selection for LED temperature sensing circuit

| OS_ADJ_LED1 | OS_ADJ_LED0 | Reference Input |
|-------------|-------------|-----------------|
| 0           | 0           | 0.03 V          |
| 0           | 1           | 0.85 V          |
| 1           | 0           | 1.65 V          |
| 1           | 1           | 2.47 V          |

- G\_ADJ\_LED<1:0>: amplifier gain selection for LED temperature sensing circuit

| G_ADJ_LED1 | G_ADJ_LED0 | Gain |
|------------|------------|------|
| 0          | 0          | 0.99 |
| 0          | 1          | 1.98 |
| 1          | 0          | 2.98 |
| 1          | 1          | 3.99 |

- SetPLS<3:2>: not implemented, read as '0'
- Rise<1:0>: controls the shape of the Active Light pulses

| Rise1 | Rise0 | Rise time of Active Light pulses (1tau - $\mu$ s) |
|-------|-------|---|
| 0     | 0     | 7   |
| 0     | 1     | 5   |
| 1     | 0     | 3   |
| 1     | 1     | 1   |

## 8.14. Window Watchdog Timer

The internal watchdog timer is a watchdog based on two different windows: an open and a closed window. During the open window the master can restart the watchdog timer. During the closed window, no restarts are accepted.

The restart (re-initialisation) of the watchdog timer happens via WatchDog Trigger Command: when a WDT command is sent, the watchdog will be restarted.

After a POR or a reset issued by the watchdog and after a wake-up from Sleep Mode (by uploading the NRM command), the window watchdog will open an active window of a time `twdt_init`, during which a watchdog restart must be issued by the  $\mu$ C. If no watchdog restart is received by the end of the open window, the  $\mu$ C will be reset.

After this initial period, the window watchdog is programmed to wait a time `twdt_closed` during which no watchdog restarts are allowed. If a watchdog restart is sent during the closed window time, the watchdog will reset the master via the MR (Master Reset) pin.

After a closed window, an open window of a time `twdt_open` will follow during which a watchdog restart is expected. If no watchdog restart is received till the end of the open window, the  $\mu$ C will be reset via the MR pin.

Changing mode between Normal Running Mode and Standby Mode will not influence the watchdog timing or state. Also a CR command will not change the used window times. The watchdog counter will not be influenced when changing mode between NRM and STBY or when uploading a CR command.

The Watch Dog Timer is disabled in Sleep Mode. Sending a WDT command in the Sleep Mode will set the Previous Command Invalid flag high. Coming back from Sleep Mode to Normal Running Mode always restarts the watchdog with the initial timing window.

This figure shows what timing windows are used in the different operating modes :



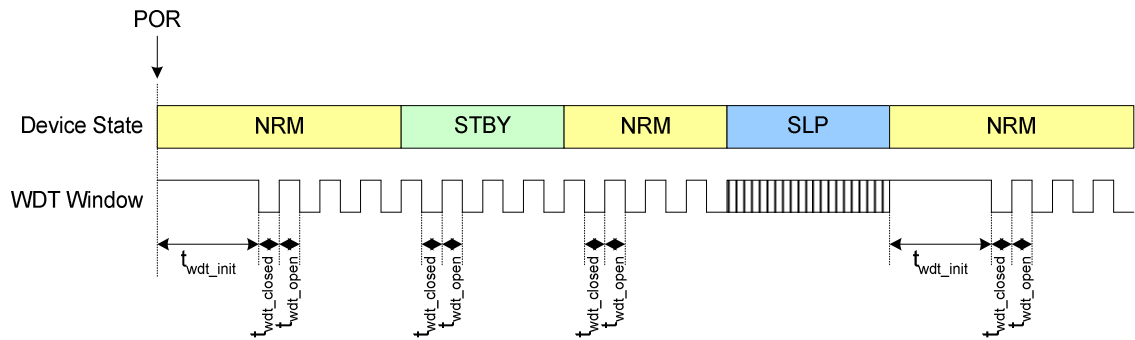


Figure 16 : Window times during different operating modes

The two figures below show the functionality of the watchdog timer :

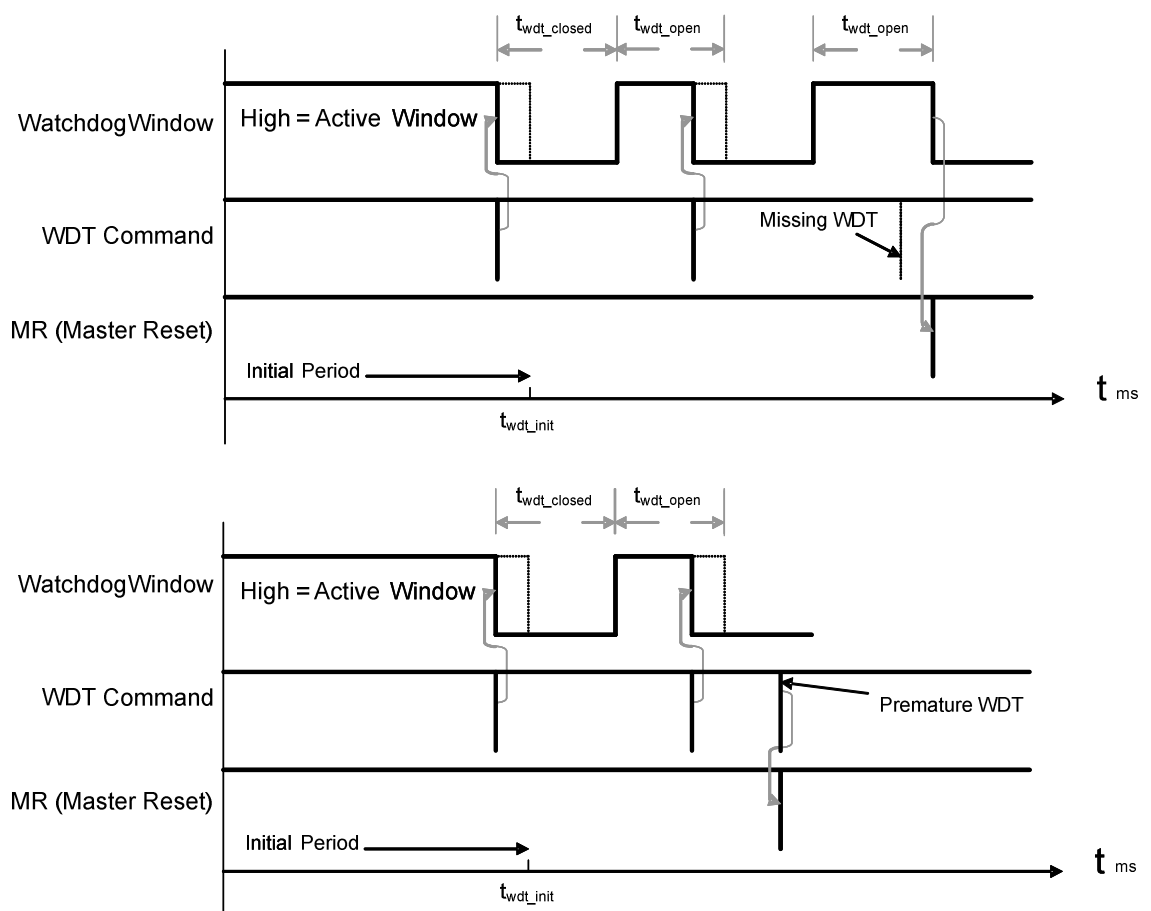


Figure 17 : Functionality of the window watchdog timer

A reset of the  $\mu C$  due to time-out of the watchdog is achieved by setting the *MR* pin low during a time  $t_{MR}$  (default state of the *MR* pin is high).

## 8.15. Reset Behaviour

### Power-On Reset

After a Power-On Reset, the device is operating in Normal Running Mode.

All internal data registers are set to their initial state :

- the device state is Normal Running Mode
- the Watchdog counter is initialized to generate the initial window time
- all registers containing (diagnostic) measurement data are initialized to 0x00
- bits 7, 4, 3 of the Internal Status Flags are cleared
- the user settings registers are set to their initial values (see Section 0)
- the 'Err' register will initialize to 0x00. However, as some voltages are continuously measured, it will reflect immediately if an error is detected or not.

The *MR* pin will be initialized to '1'. The *DR* pin will be initialized to '0', but after the time  $t_{\text{startup}}$  it will switch to '1' to indicate that the device is ready to accept the first command (see also Section 0).

The output of the *MISO* pin is depending on the *CS* state: if *CS* is high, the *MISO* pin is in tri-state. If *CS* is low, the output of the *MISO* pin is undefined, but either logic high or logic low.

### CR Command

At every upload of the CR command, the device returns to the state like it is after a Power-On-Reset, except for the Watchdog counter and the state of the *MR* line. The Watchdog counter and the state of the *MR* line will not be influenced by uploading a CR command. Also, the CR command will not change the contents of bits 1 and 0 of the register 'Rst'.

After a CR command the *DR* pin will be kept low during a time  $t_{\text{startup}}$ .

### Read-out

At the end of each read-out, all registers containing (diagnostic) measurement data are cleared to 0x00.

### Watchdog time-out

When a reset occurs due to a watchdog time-out, the *MR* pin will go low for a time  $t_{\text{MR}}$ . The Watchdog counter will be initialized with the window time  $t_{\text{wdt\_init}}$ . All other states, lines and registers of the ASIC will not be affected.

### Changing operation mode

When changing operation mode (RSLP, CSLP, RSTBY, CSTBY, NRM) the right status flags are set.

Changing operation mode will not affect the user settings registers and the (diagnostic) measurement data registers.

The *DR* pin will be set to '0' and after the time  $t_{\text{wakeup\_slp}}$  resp.  $t_{\text{wakeup\_stby}}$  it will be set to '1', when waking up from Sleep resp. Standby Mode.

## 8.16. Supply Voltage Behaviour

The next figure gives an overview of the behaviour of the POR, the MR/Watchdog and the under/overvoltage error flags for changing power supply voltage.

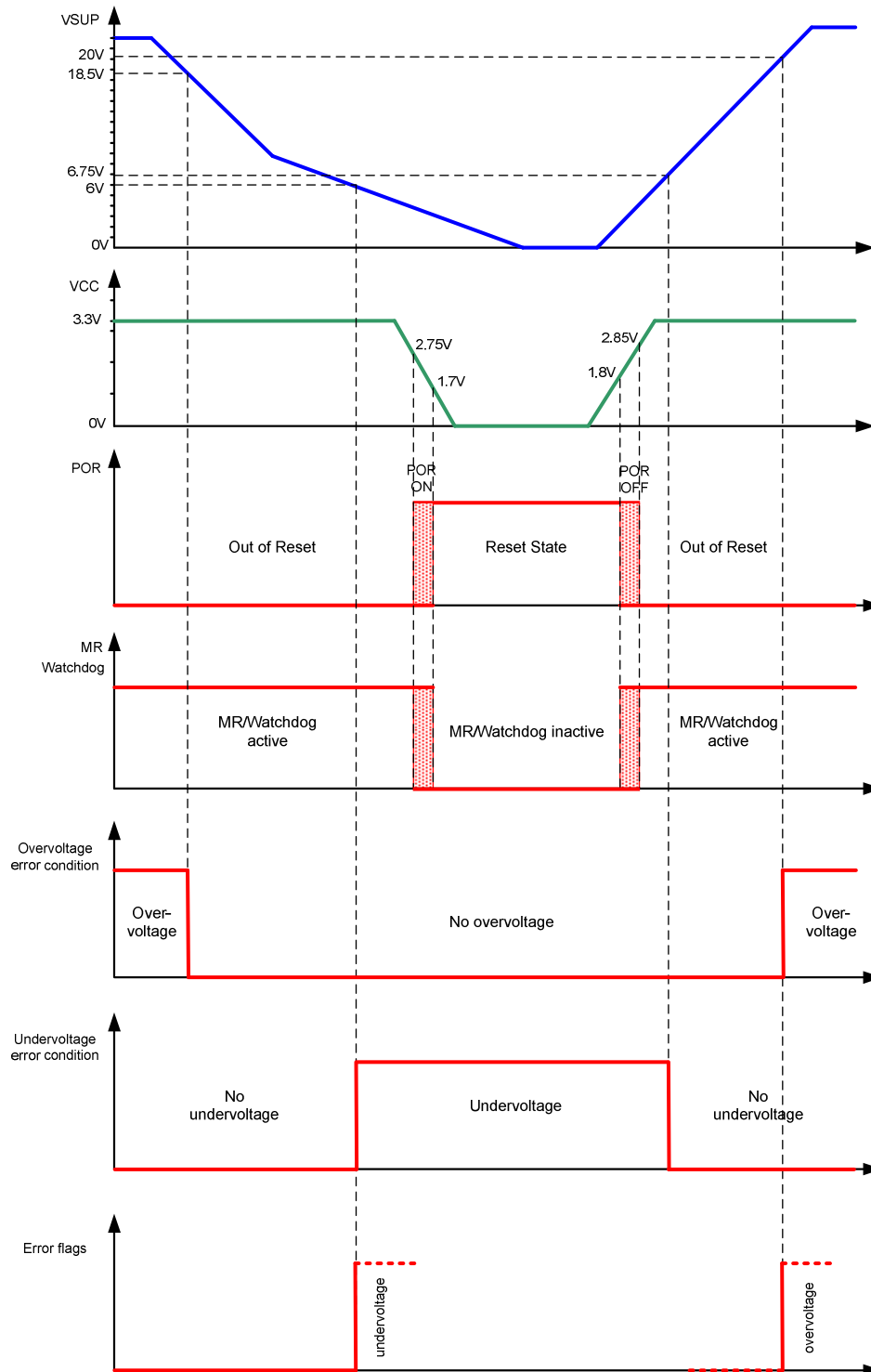


Figure 18 : Supply Voltage Behaviour

## 8.17. Wake-up from Sleep or Standby

The figure below shows what happens when switching operation mode, and the behaviour of the *DR* pin, the *SLEEPB* pin and the watchdog timer.

When a NRM command is uploaded during Sleep or Standby, the following will happen:

- the *DR* pin goes low for a time  $t_{\text{wakeup\_stby}}$  or  $t_{\text{wakeup\_slp}}$
- the watchdog timer is initialised and starts counting, when waking up from Sleep
- the device changes to Normal Running Mode, enabling the appropriate blocks
- the *SLEEPB* pin goes high

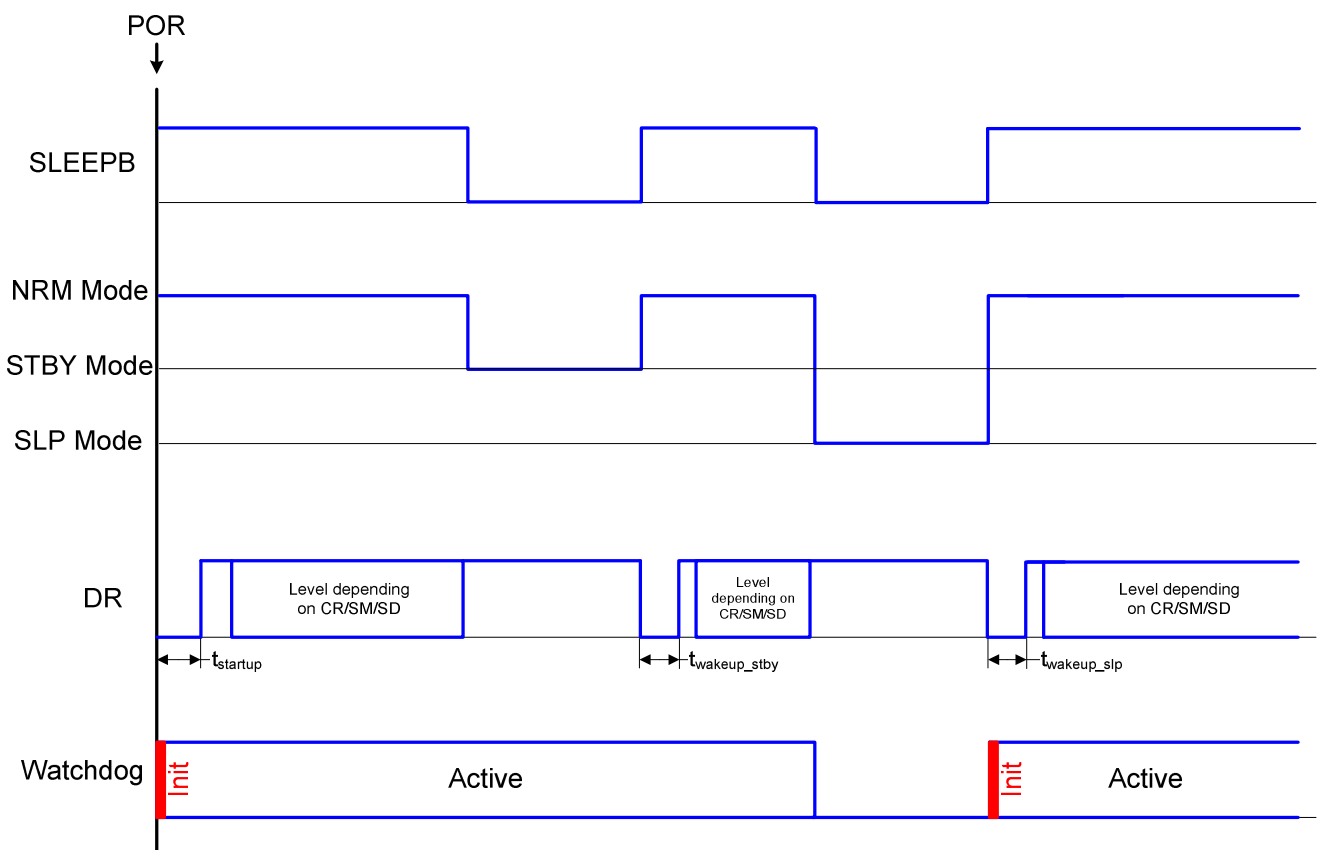


Figure 19 : Behaviour of DR and Watchdog when switching mode

## 8.18. CRC Calculation

The 8-bit CRC calculation will be based on the polynomial  $x^8 + x^2 + x^1 + x^0$ . This polynomial is widely used in the industry, it is e.g. used for generating:

- the Header Error Correction field in ATM (Asynchronous Transfer Mode) cells
- the Packet Error Code in SMBus data packets

Some probabilities of detecting errors when using this polynomial:

- 100% detection of one bit errors
- 100% detection of double bit errors (adjacent bits)
- 100% detection of two single-bit errors for frames less than 128 bits in length
- 100% detection of any odd number of bits in error
- 100% detection of burst errors up to 8 bits
- 99.61% detection of any random error

A possible hardware implementation using a Linear Feedback Shift Register (LFSR) is shown in the figure below:

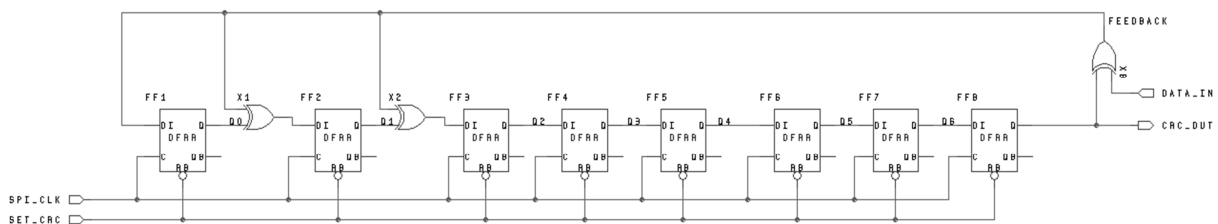


Figure 20 : 8-bit CRC implementation using a LFSR

The generation of the CRC requires the following steps:

Reset all flip-flops

0x00 is the initial value, shifting in all zeroes does not affect the CRC

Shift in the read-out data bytes. First byte is Data Byte 1 (= Internal Status Flags), last byte is Data Byte (X+1) (with X defined in Figure 12).

When the last byte has been shifted in, the flip-flops contain the CRC: CRC=FF[8..1].

An easy method to check if there were no transmission errors is to calculate the CRC of the whole read-out data stream including the CRC Byte. When the calculated CRC results in 0x00, the transmission was most likely error free. If the resulting CRC is not equal to zero, then an error occurred in the transmission and the complete data stream should be ignored.

Some CRC results for example messages are given in Table 25.

| ASCII String messages  | CRC result |
|--|------------|
| -None-   | 0x00       |
| "A"  | 0xC0       |
| "123456789"  | 0xF4       |
| a string of 256 upper case<br>"A" characters with no line breaks | 0x8E       |

Table 25 : CRC examples

## 8.19. Global Timing Diagrams

A global timing diagram with separate SM-RO cycles is given in Figure 21. After power-up there is a Power-On-Reset phase (POR) to initialize the sensor into a reset state. When the device is ready to accept the first command, the *DR* pin goes high. In Figure 21 the first command is the WR command to define the contents of the user registers (optionally). The first measurement cycle is e.g. initiated by uploading a SM command. After completion of the measurement cycle, the *DR* goes high. This indicates that the read-out cycle can be started. A RO command has to be uploaded to bring the data on the *MISO* pin. When the read-out is completed, a new measurement cycle can be started. In Figure 21 a SM command is used. This starts a next measurement cycle. Once *DR* is high, a read-out can be done again.

In between different Measurement/Read-Out cycles, the user registers can be changed with WR commands. Optionally those registers can be read back with the RR command to check if the right values were uploaded.

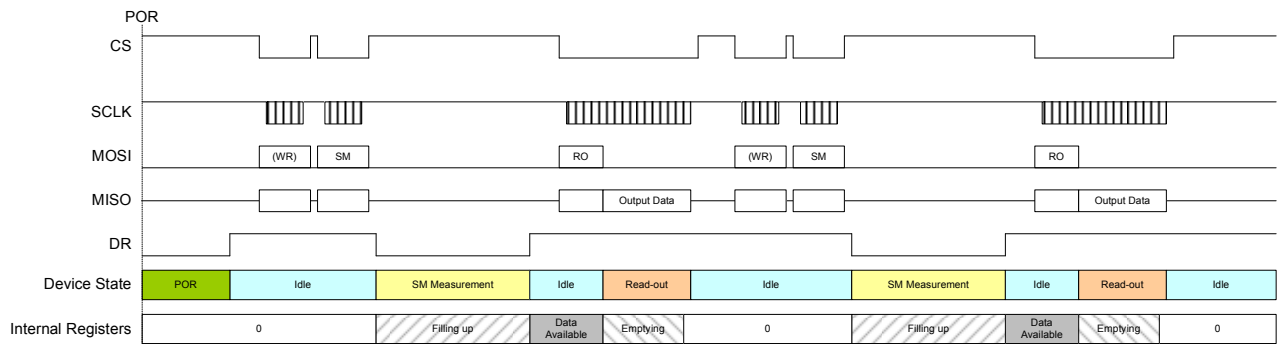


Figure 21 : Global timing diagram with separate SM-RO

Figure 22 shows a timing diagram wherein separate SM-RO cycles are mixed with combined SM-RO cycles. After the Power-On-Reset phase, a SM measurement cycle is started. Once the *DR* pin is high, the data can be read out. A SM command with extra clocks is used to combine the read-out and the start of the next measurement cycle. With the extra clocks, the data of the internal registers is transferred to the *MISO* pin. When the *CS* pin goes high, the next measurement cycle (SM) will be started.

Once the *DR* pin is high, a normal RO command is uploaded to bring the data to the *MISO* pin. If needed, the settings in the user registers can be changed with the WR command and optionally the RR command can be used to check if the right values were uploaded.

A new measurement cycle can be started with e.g. a normal SM command. When the *DR* pin is high, the data can be transferred by uploading e.g. a SM command that combines the read-out and the start of a new measurement cycle.

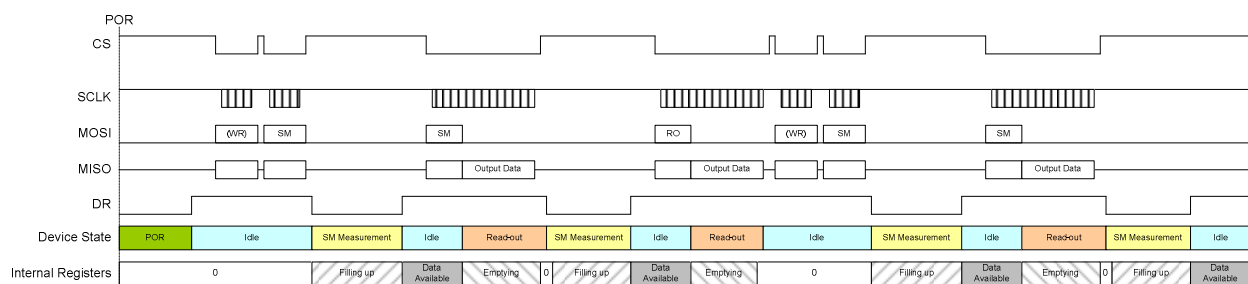


Figure 22: Global timing diagram with separate SM-RO and combined SM-RO together

## 9. Application Information

### 9.1. Application circuit

The exact drive circuit for the LEDs, the shunt resistor, photodiodes and power supply filter components can change for each application. The table below summarizes a possible set of external components. A typical application diagram is shown in Figure 23. Note that the capacitor on Cext has a defined range of 10..100nF, however 68nF is highly recommended to give the best results.

| Ambient Detector | Active Light Detector | LED         |
|------------------|-----------------------|-------------|
| SFH2270          | BPW34FA               | SFH4232     |
| SFH3410          | VBPW34FA              | SFH4250     |
| SFH3710          | VBP104FAS             | SFH4253     |
| SFH5711          | SFH2400FA             | SFH4257     |
| SFH2430          | SFH2701               | VSMY1850X01 |
| BP104S           |                       | VSMY3850    |
| TEMD6010FX01     |                       | VSMB3940    |
| TEMD6200FX02     |                       |             |
| TEMT6000X01      |                       |             |
| TEMT6200FX01     |                       |             |

Table 26 : External Components

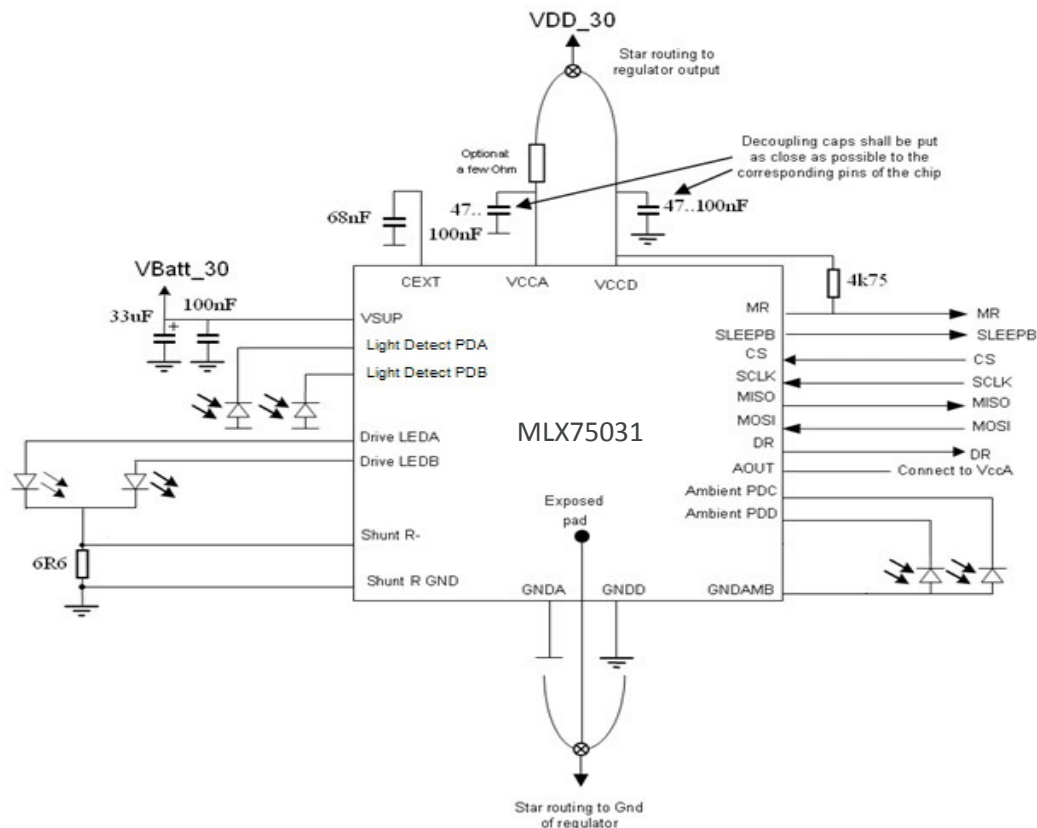


Figure 23 : Typical application circuit

## 10. Standard information regarding manufacturability of Melexis products with different soldering processes

Our products are classified and qualified regarding soldering technology, solderability and moisture sensitivity level according to following test methods:

### **Reflow Soldering SMD's (Surface Mount Devices)**

- IPC/JEDEC J-STD-020

Moisture/Reflow Sensitivity Classification for Nonhermetic Solid State Surface Mount Devices (classification reflow profiles according to table 5-2)

- EIA/JEDEC JESD22-A113

Preconditioning of Nonhermetic Surface Mount Devices Prior to Reliability Testing (reflow profiles according to table 2)

### **Wave Soldering SMD's (Surface Mount Devices) and THD's (Through Hole Devices)**

- EN60749-20

Resistance of plastic- encapsulated SMD's to combined effect of moisture and soldering heat

- EIA/JEDEC JESD22-B106 and EN60749-15

Resistance to soldering temperature for through-hole mounted devices

### **Iron Soldering THD's (Through Hole Devices)**

- EN60749-15

Resistance to soldering temperature for through-hole mounted devices

### **Solderability SMD's (Surface Mount Devices) and THD's (Through Hole Devices)**

- EIA/JEDEC JESD22-B102 and EN60749-21

Solderability

For all soldering technologies deviating from above mentioned standard conditions (regarding peak temperature, temperature gradient, temperature profile etc) additional classification and qualification tests have to be agreed upon with Melexis.

The application of Wave Soldering for SMD's is allowed only after consulting Melexis regarding assurance of adhesive strength between device and board.

Melexis is contributing to global environmental conservation by promoting **lead free** solutions. For more information on qualifications of **RoHS** compliant products (RoHS = European directive on the Restriction Of the use of certain Hazardous Substances) please visit the quality page on our website: <https://www.melexis.com/en/quality-environment>

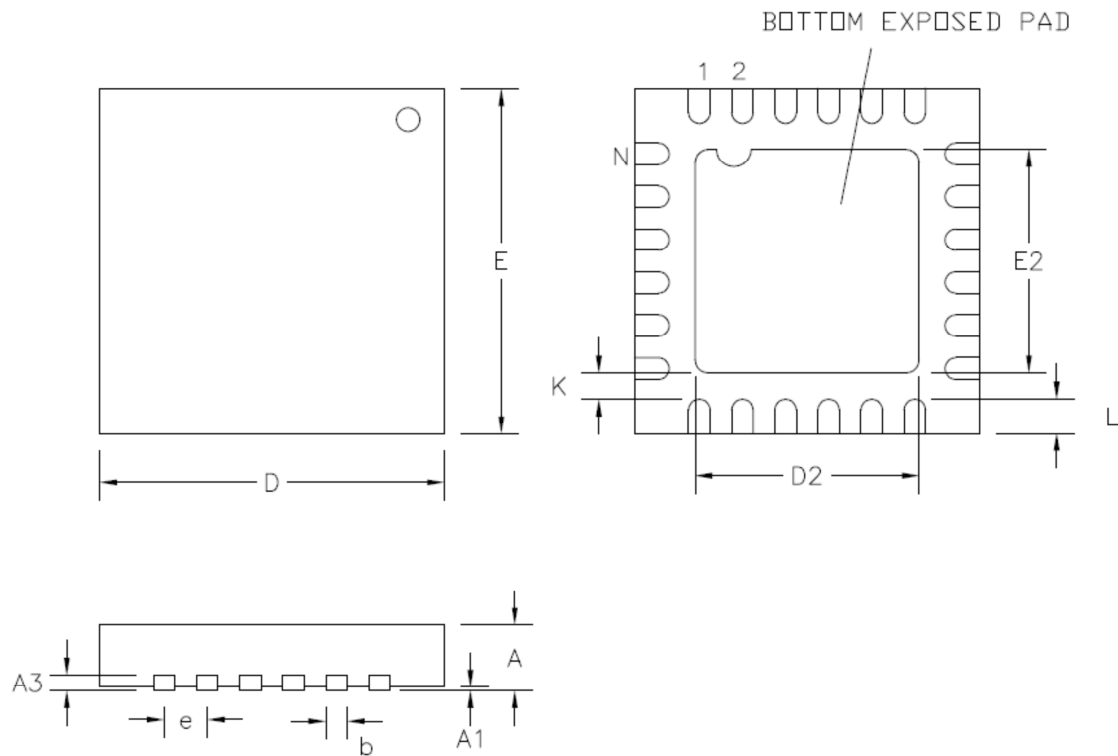


## 11. General Recommendations - ESD/EMC Precautions

The application circuit board should be designed to minimize electro-magnetic compatibility problems.  
The chip is an ESD sensitive device and should be handled according to guideline [EN 61340-5-1](#) ("Protection of electronic devices from electrostatic phenomena").

## 12. Package Information

### 12.1. QFN 4x4 (24 pins): Quad Flat No-lead with exposed pad



|      | D x E                | N  | e             |     | A    | A1   | A3   | D2   | E2   | L    | K    | b    |
|------|----------------------|----|---------------|-----|------|------|------|------|------|------|------|------|
| Quad | All dimensions in mm |    |               |     |      |      |      |      |      |      |      |      |
|      | 4 x 4                | 24 | 0.50<br>±0.05 | min | 0.80 | 0.00 | 0.20 | 2.50 | 2.50 | 0.35 | 0.20 | 0.18 |
|      |                      |    |               | max | 1.00 | 0.05 | REF  | 2.70 | 2.70 | 0.45 | –    | 0.30 |

Table 27 : Package Drawing Dimensions

| Package | $\Theta_{jc}$ [°C/W] | $\Theta_{ja}$ [°C/W]<br>(JEDEC 1s0p board) | $\Theta_{ja}$ [°C/W]<br>(JEDEC 1s2p board) |
|---------|----------------------|--|--|
| QFN 4x4 | 16                   | 154  | 50   |

Table 28 :  $\Theta_{JA}$  values

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